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INTEGRATION OF SNEAK ANALYSIS WITH DESIGN

SoHaR Incorporated

Jeff Miller



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This report documents the work in the creation of a software package to be used by a design engineer to prevent sneak circuit failures in a new design. Sneak Circuit Analysis for the Common Man was an interim report that was issued representing the manual procedure for identifying possible sneak circuits. This report presents the automated version to be used on an IBM PC under MS/DOS. The Sneak Circuit Analysis (SCA) software package uses the ORCAD III schematic capture program to analyze the circuitry. SCA will search for potential sneak paths and identify them for the user. SCA will then offer suggestions to the user to correct the design weaknesses. The software package handles analog as well as digital circuits and for very large networks, a sectional analysis is possible.							
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PREFACE

This is the final report for a two year study entitled Integration of Sneak Analysis with Design conducted by SoHaR Incorporated (prime contractor) and Fail-Safe Technology Corporation as subcontractor for the Rome Air Development Center, Griffiss AFB, NY, under contract F30602-87-C-0193. Technical direction for the study has been provided by Mr. Bruce Dudley.

The author wishes to acknowledge the outstanding effort of J. Agron and H. Baik of SoHaR for developing, respectively, the C code and M.1 knowledge base rules for the SCAT system. The author also wishes to acknowledge the contributions of K. Smernoff of Fail-Safe Technology for performing the SCA user survey, and J. Sivak and D. Friedman of Fail-Safe Technology for performing the SCA control and monitoring study. Finally, the author wishes to thank B. Dudley of RADC and H. Hecht of SoHaR for their technical guidance, and P. Crane of SoHaR for assisting in the text and graphics processing required for this report.



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LIST OF ACRONYMS

CAD Computer aided design

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- CAE Computer aided engineering
- CDR Critical Design Review
- DCA Design Concern Analysis
- Data Items Description DID
- EDIF Electronic Data Interchange Format
- EIA Electronic Industries Association
- FCA Functional Configuration Audit

FMEA Failure Modes and Effects Analysis

FSCA Functional SCA

FSED Full Scale Engineering Development

- Input/output I/O
- PA Program Authority
- PC Personal computer
- SCA Sneak circuit analysis
- SCAT SCA Tool
- SOW Statement of Work

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EXECUTIVE SUMMARY

This report documents the results of a two year study to make sneak circuit analysis (SCA) more effective by simplifying the procedure and integrating it into the design process. This effort entailed (1) the conduct of a literature search and an SCA user survey to ascertain current methodologies and techniques associated with SCA and its support of other reliability analyses, (2) development of a simplified, manual procedure which provides design rules for avoiding sneak paths and guidelines for identifying common types of sneak conditions, and (3) development of an automated version of the procedure integrated with a popular, computer-aided design (CAD) tool.

The literature search identified two comprehensive, non-proprietary sources for SCA clue lists. In all, six clue lists were evaluated, with clues falling into one of two broad categories:

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- Those applicable to specific topological patterns in switching circuits and used for identifying sneak paths.
- Those applicable to specific circuit devices or functions and used for identifying design concerns and to a lesser extent sneak paths.

The most significant problems associated with the clue lists are their lack of structure to facilitate culling inapplicable clues, inclusion of subjective areas in what should be an objective analysis, and inclusion of topics better handled by other analyses.

In the user survey, 42 potential SCA users were contacted, and seven provided useful information by responding to a survey questionnaire. The findings indicated network trees are required for a comprehensive search for sneak paths. However, these trees are difficult to implement in that they require significant data processing (performed by proprietary software) for (1) generating a circuit connectivity list (net list) defining the entire system, (2) filtering redundant or non-essential information from the list, and (3) partitioning the net list into segments suitable for manual application of the clues. This study concentrated on developing guidelines for identifying sneak circuits that are independent of circuit topology, thereby eliminating the need to generate network trees.

Additional findings of the user survey were:

- The current, prevalent procedure for SCA consists of automated formatting and partitioning of schematic and net list data, semi-automatic generation of network trees, and manual application of sneak clues and design concerns.
- Efforts are underway for reducing the requisite computer resources from a mainframe to a workstation.
- Functional networks (e.g., block diagrams) are rarely analyzed.

- The most prevalent types of analyses for which SCA databases and results are shared are FMEA and fault tree analysis.

The last point was supported by a survey of related analyses conducted as part of this study. The analyses survey also found that fault tolerance design compliance analysis has an important interface with SCA because the criticality of the functions that make SCA necessary also require fault tolerance, and the latter must address the absence of design hazards (such as sneak circuits) that can defeat its purpose.

The manual SCA procedure was documented in a separate report entitled *Sneak Circuit Analysis for the Common Man* (report number RADC-TR-89-223). The procedure is intended for the design engineer or electronics reliability analyst without prior SCA experience. The report includes a simplified set of sneak related design concern clues that can be applied to circuitry at the assembly or subsystem levels by personnel who understand the operation of the circuitry and the devices comprising it. Supplementary explanations, problem illustrations, and recommended solutions are also provided. The clues address areas such as improper switching elements in power return lines, timing problems associated with relay circuits, and problems associated with application and removal of power to digital circuitry. The report can also serve as a guidebook for familiarizing engineers with the techniques for designing circuits free of commonly encountered sneak problems.

An SCA tool (SCAT) was developed to automate the manual procedure and to extend it to include automatic identification of sneak paths in switching circuits. An example of a sneak path identified by SCAT is shown in Figure 1. The highlighted path begins at the point labeled SRC, passes through relay K1 (switch contact), switch S2, and back through relay K1 (coil) before terminating at ground. The sneak results in an oscillatory condition that alternately energizes and de-energizes the relay. SCAT designates the path by listing the affected devices in their order of appearance along the path (*i.e.*, K1-S, S2, K1-C).

The SCAT program requires only a few minutes to run, the actual time being dependent upon the size of the circuit analyzed. As in the manual procedure, the SCAT user must understand the operation of the circuit under analysis in order to evaluate identified sneak paths and to respond to prompts addressing design concerns. The program, consisting of an expert system knowledge base augmented by external code, runs on IBM-PC/XT, /AT or 80386 class microcomputer running under MS-DOS. The user must provide the M.1 (Teknowledge, Inc.) expert system inference engine software environment to run the SCAT program. Input to SCAT consists of net lists generated by a popular, commercially available schematic capture program (OrCAD/SDT III) that must also be provided by the user.

This report concludes with an evaluation of current SCA control and monitoring procedures and in this regard recommends revision of two existing DIDs. The revisions address data requirements tor performing follow-up SCA effectiveness and thoroughness studies. Examples of the revised DIDs are provided in the appendices to this report as is a detailed user's manual for the SCAT program.



Figure 1. Sneak Path Identified by the Automated Procedure

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Chapter 1 INTRODUCTION

This report documents the results of a two year study to make sneak circuit analysis (SCA) more effective by simplifying the procedure and integrating it into the design process. Sneak circuit analysis is defined in MIL-STD-785B, the military standard for reliability programs, as a procedure "to identify latent paths which cause occurrence of unwanted functions or inhibit desired functions, assuming all components are functioning properly". The procedure is particularly applicable to military systems because of the potential for identifying and correcting design weaknesses that could lead to catastrophic failure¹. However, the procedure is not as widely used as it should be primarily because:

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- Its conduct is expensive, being highly labor intensive and often requiring an independent contractor having specialized tools and trained analysts.
- The effort requires complete documentation and therefore is usually performed late in the design cycle or early in the production phase when changes are more costly and difficult to implement.
- The separation of the organization performing the analysis from the organization responsible for the design often leads to problems being incorrectly identified or to identified problems not being corrected.

The objective of this study was to overcome these deficiencies by simplifying the procedure and integrating it with other analyses performed during the design phase. To this end, we (1) conducted a literature search and a SCA user survey to ascertain current methodologies and techniques associated with SCA and its support of other reliability analyses, (2) developed a simplified, manual procedure which provides design rules for avoiding sneak paths and guidelines for identifying common types of sneak conditions, and (3) developed an automated version of the procedure integrated with a popular computer-aided design (CAD) tool. The procedures are intended for the reliability analyst or design engineer without prior SCA experience.

The results of these three tasks are described in the remainder of this report. Chapter ², Background and Interim Results, summarizes conventional SCA procedures and briefly discusses objectives and accomplishments during the first half of this contract including development of a new, manual procedure. Chapter 3, Automated SCA, describes the development and operation of the new, automated procedure, its integration with existing design tools, and its relevance to other reliability analyses. Chapter 4, SCA Control and

¹ This report does not address a related procedure for software, Sneak Software Analysis.

Monitoring, presents recommendations for data collection to assist in managing and evaluating contractual SCA efforts. Chapter 5, Recommendations for Further Study, addresses areas that were beyond the scope and resources of the current study. A user's manual for the automated SCA tool (SCAT) and proposed data items for control and monitoring of SCA appear in appendices to this volume of the report.

The SCAT software, consisting of an expert system knowledge base augmented by programs coded in C, is documented in Volume II of this report. The documentation consists of printouts of the C source code and knowledge base, both of which include extensive comments, and descriptions of the program flow and data structures utilized. For ease of reference, each major subprogram and knowledge base segment is listed in the table of contents for Volume II.

This study was a two year effort commencing on September, 1987. SoHaR Incorporated, the prime contractor for this study, was responsible for developing the manual and automated procedures described in the report and for writing the C-code and M.1 knowledge bases required for SCAT. Fail-Safe Technology Corporation was the principal contributor for development of the control and monitoring procedures. An analysis and evaluation of candidate expert systems for the automated procedure was performed by Dr. Lawrence Press, a consultant to SoHaR. Overall technical direction was provided Mr. Bruce Dudley, RADC/RBER.

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Chapter 2 BACKGROUND

SCA has been in use for over 20 years, the first major computer aided version having been developed for the NASA Apollo program in 1967 by the Boeing Company [CLAR76]. The original application of SCA was for switching and relay networks for engagement and disengagement of control functions such as those used in automatic pilots and in missile and spacecraft systems. These applications are referred to as "electro-mechanical circuits" in MIL-STD-785B, where SCA is specified as Task 205; in this report the shorter terms "switching circuits" or "relay circuits" are used (the two expressions are considered synonymous). The change in terminology also recognizes that relays are no longer exclusively electro-mechanical devices.

2.1 Conventional Techniques

The techniques for identifying topological sneak paths in switching or relay circuits are applicable to all functions that evaluate Boolean variables exclusively. Such circuits may be comprised of manual or sensor-operated switches, electro-mechanical or solid state relays, or combinatorial digital logic circuits (but not sequential or memory-dependent ones). The logic circuits are modeled by their switching circuit (switch and diode) equivalents. Functional paths such as those between relay coil and contact and between poles of a multiple pole switch are also modeled.

The primary objectives of SCA in switching circuit applications are to uncover sneak problems in four principal areas:

- Sneak Paths Unintended electrical paths within a circuit and its external interfaces.
- Sneak Timing Unexpected interruption or enabling of a signal due to switch circuit timing problems.
- Sneak Indications Undesired activation or de-activation of an indicator.

Sneak Labels Incorrect or ambiguous labelling of a switch.

Because it was found that frequently encountered causes of sneak circuits were associated with distinct topological patterns on circuit diagrams, the identification of these patterns and the recording of specific circuit attributes applicable to each pattern were considered efficient means of using past experience to guide a current analysis. This conventional approach led to the development of semi-automated methods of isolating the topological patterns in relay circuits and to the generation of clue lists applicable to each type of topological pattern. The most significant of these patterns are the "Y" (power dome), inverted "Y" (ground dome), and "H" (cross-tie) where in each case the pattern depicts power flow from source(s) to ground(s). Additional patterns for analog and digital signal flow have also been developed.

A simple example of the conventional approach is demonstrated with the help of Figure 2-1. The functional circuit depicted in part A of the figure is intended to prevent routine opening of a cargo door unless the aircraft is on the ground. For this reason, the primary switch that controls the door opening is energized through the Gear Down contactor. A secondary switch permits emergency operation of the door when the gear is not down. Due to a sneak path, closure of the emergency door switch when the primary switch is closed will inadvertently lower the landing gear.

In the conventional SCA approach, accurate, production-level drawings of the circuitry are required to insure all circuit paths are considered by the analysis. The circuit interconnection data are partitioned for constructing "network trees" to filter non-relevant schematic data and generate a visually simplified presentation of the circuit. Several versions of the trees may be required to analyze circuit switching configurations corresponding to a timed sequence of system states.

The topology of each network tree is analyzed for the appearance of the key patterns; for the cargo door example, an "H" pattern is recognized. The H pattern is more apparent from the network tree drawn in part B of Figure 2-1 than from the circuit schematic drawn in part A. The tree is constructed by tracing all possible paths from power to ground assuming all switches are closed, and is drawn such that power flows from top to bottom. Appropriate topologically oriented sneak clues are then applied to the pattern, and if an answer is affirmative, the sneak path is identified. In this example, it can be prevented by insertion of a diode in series with the primary switch as shown in part C of the figure.

In recent years, the scope of SCA has been expanded to include clues for identification of design concerns in analog and digital circuitry. Some design concerns imply the existence of a sneak path or sneak timing while others are completely unrelated to sneak conditions and merely indicate a violation of good design practice. Design concern clues aid the analyst to identify potential problems affecting specific devices or circuit functions.

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Figure 2-1. Example of a Sneak Circuit

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SCA is a highly labor intensive task requiring significant computer resources for support. For this reason, it is typically applied only to mission or safety critical areas of a system. The circuit interconnection data for these sub-systems can be quite complex, with documentation spread over many drawings (*e.g.*, circuit card schematics, inter-card wiring lists, and subsystem cabling diagrams). Automated techniques for capturing the circuitry and generating network tree interconnection data have been developed and have proved to be indispensable for efficient, accurate and thorough analysis of large systems. The software for performing the circuit data capture and tree generation is considered highly proprietary by those contractors that have developed an SCA capability. Furthermore, a team of specially trained analysts are required to apply sneak clue lists (many of the lists are considered proprietary as well) to the hundreds of network trees that are typically generated. For these reasons, performance of the analysis is limited to SCA contractors in all but the simplest of cases.

2.2 Interim Results

In order to build a foundation for the development of a simplified integrated version of SCA, a data collection task was performed. The task consisted of three major activities:

- 1. A literature search
- 2. A user survey
- 3. A survey of related analysis techniques

The collected data was evaluated in the specific areas of clue lists, SCA techniques and related analyses. The data and the evaluation results are summarized in the following sections.

2.2.1 Literature Search and Analysis

The literature search identified existing, available information related to sneak analysis techniques, methods of execution, and problem areas. Sources included the DTIC, NTIC and UCLA library data bases. The search also identified design tools that could be integrated with SCA to enable a design engineer to perform the analysis as an ongoing part of the design process. The tools investigated were (1) computer aided design products presently being used for electronic equipment design and (2) expert system building tools for test and analysis applications. A listing of significant references appears in the bibliography of this report.

The performance of SCA is centered on the use of clue lists serving as checks or guides for the analysis. Two broad categories of clues can be distinguished:

- Clues applicable to specific topological patterns in switching circuits and used for identifying sneak conditions.

- Clues applicable to specific circuit devices or functions and used for identifying design concerns and to a lesser extent sneak conditions.

Two of the references identified by the literature search are comprehensive, non-proprietary sources for SCA clues. This is significant since sneak clue lists have traditionally been considered proprietary and were not published. Reference [NP3634] includes 106 clues in three major categories: (1) tree topograph, (2) piece-part and circuit configuration, and (3) design concerns. Clues in the latter category are accompanied by explanations to assist less experienced analysts. Reference [MS1543B] includes 128 clues also in three major categories: (1) functional, (2) design oriented, and (3) design concern. The design oriented clues are written so as to enable identification of sneak conditions (*i.e.*, paths, timing, indications and labels) without reference to network tree topographs.

An evaluation of these clue lists and four others obtained during the course of this study (covering approximately 150 unique clues) revealed that while the clue lists provide a valuable guide for relatively inexperienced personnel, they are time consuming and tiring to use because they:

- Lack structure by not being arranged in a manner that permits skipping a number of subordinated items when a negative (no sneak circuit possible) finding is reached for a top level clue.
- Mix areas in which subjective analysis is required (such as the appropriateness of labels) with areas in which clear decisions are possible (such as the possibility of unwanted current flow).
- Include questions that are clearly the responsibility of the design engineer (such as the compatibility of loads with power sources).

Information on problems related to the performance of SCA has been amply reported in the literature ([BALD87], [BURA82]) and are evident in final reports of specific SCA applications. The major problem areas arise from performing SCA too late in the development cycle by a SCA specialty team too removed from the design effort and from the diversity of interests of the performing organization with the organization responsible for the design. Thus, the results of a thorough analysis are typically contested by the design organization either because the sneak circuits identified in fact do not pose a problem or because their degree of significance does not justify the cost of their removal. The solution is to simplify the analysis such that it can be applied in the early phases of the design effort either by design personnel or under their guidance.

The purpose of the CAD survey was to identify methods by which an automated SCA tool could easily interface with a schematic capture tool and to select a specific schematic capture product for implementing this interface. These products accommodate on-screen graphical and textual editing of circuit schematics and include provisions for outputting circuit interconnection data in various formats for use by other products such as those for circuit board trace routing and circuit or logic analysis. Methods of integration that were considered included feedback of SCA results into the on-screen schematic, incorporation of

SCA clues into the design error checking facilities found in many of the products, and use of the circuit interconnection data (the schematic net list) as an input for the SCA tool.

A voluminous amount of information on CAD techniques is available in the literature. In order to focus on the study objectives, the scope of the search was limited to schematic capture products capable of running on a personal computer. The personal computer (*e.g.*, the IBM-PC family of desktop microcomputers) is becoming prevalent in engineering organizations as its computing performance and memory capacity have increased, and a growing number of circuit design and analysis applications are available that take advantage of these gains. PC-based schematic capture and circuit analysis products provide a cost-effective means for interfacing SCA with design data particularly during the early phases of a development effort.

The extent of the investigation of schematic capture products performed during this study is shown in Table 2-1. Data for the table were compiled in August of 1988. In addition to basic product information (year product was introduced, number of sales, and cost), the table also includes the following technical characteristics:

Library size	The number of unique, graphical component symbols available for schematic editing.					
Library type	Type of components covered; analog (A), digital (D), or both.					
EDIF Net List	Compatibility with the EDIF industry data formatting standard.					
Layout Tool	Product can also perform component layout.					
Analysis Tool	Product can also perform circuit or logic analysis.					
External Annotation	Capability for external programs to modify the schematic.					
Hierarchical Schematics	Capability for representing schematic data hierarchically in addition to a flat, multi-page format.					
Rule Checking	Provisions for identifying violation of design rules.					
Video	Compatible with high resolution color monitors (C), high resolution monochrome monitors (M) or both (B).					

Based upon this investigation, the possibility of displaying SCA results within the on-screen schematic was considered impractical because none of the products surveyed provided a means for graphically highlighting a specific component or path, and except for one product² "hooks" were not provided in their software for a user to do so. An additional objection for attempting this involves the MS-DOS operating system for the PC. The user

²Product "B" in Table 2-1 provides an open database and ASCII file formats.

Table 2-1. 1988 Survey of PC-Based Schematic Capture Products

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would have to manually perform the time consuming steps of exiting and re-entering the programs each time he desired to view the SCA results on the schematic.

The possibility of adding sneak circuit checklists to CAD schematic capture products was also investigated. Most schematic capture products include a rule checking capability for identifying certain types of drawing errors. The rule checking code, however, is in a closed format that cannot be modified without detailed knowledge of the entire schematic capture program. Alternatively, the net list output of the captured schematic can be used as an input to an external program for automating the SCA checklists. This latter approach is the one chosen for SCAT and is described later in this report.

Of the products surveyed, OrCAD/SDT was the one selected for integration with the automated SCA tool because of its compatibility with MS-DOS, low cost, wide popularity, and provisions for generating net lists in an industry standard format (specifically, Electronic Data Interchange Format, or EDIF).

Earlier work by SoHaR demonstrated an advantage for using expert system technology to aid the application of SCA clues. This technology is central to the automated version of SCA being developed under this study. A survey of PC-based expert system shells was undertaken to facilitate the selection of an optimum tool for automating the analysis. In addition, eleven expert system shells were evaluated in terms of execution efficiency, development efficiency, user interface, developer interface, external interface, inference process, knowledge representation, and developing company policy regarding the use of the shell as part of another product.

2.2.2 User Survey

A survey of vendors of SCA and of those who require or specify its performance was undertaken to determine the current state of the art and practice of the analysis technique. Approximately 42 organizations were identified as prospective SCA users and contacted regarding our request for completing a survey questionnaire. The organizations are listed in Table 2-2. As indicated by the first column in the table, these were either prime contractors or government organizations. As indicated by the last column in the table, most declined to participate, either because they in fact did not use or perform SCA (half of the prime contractors contacted were SCA users) or did not wish to divulge the requested information. Seven did respond, and a summary of the data they provided appears in Table 2-3.

TYPe	Company	Location	Individual	sca	Quest	Reply
NACA	NASA Headmuarters	Washington, DC	Charles Mertz	Yes	Po Y	QN
Prime	Aerospace Corporation	Manhattan Beach, CA	Owen Refling	No No	No	
Prime	Aerospace Corporation	Manhattan Beach, CA	Jim Egan	No	No	,
Prime	Aerospace Corporation	Manhattan Beach, CA	Larry Maynard	No	No	
Prime	Aerospace Corporation	Manhattan Beach, CA	Walt Dennis	No	No	•
Prime	Aerospace Corporation	Manhattan Beach, CA	Bob Constant	No	No	•
Prime	Boeing Aerospace Operations	Houston, TX	Robert Poirier	Yes	Yes	Yes
Prime	General Dynamics Convair Division	San Diego	Bernard Peyton	Yes	Yes	No
Prime	General Dynamics Convair Division	San Diego, CA	Charles Pace	Yes	Yes	No
Prime	General Dynamics Convair Division	San Diego, CA	William Benn	Yes	No	1
Prime	General Dynamics Convair Division	San Diego, CA	John Heronemus	Yes	٥N	'
Prime	General Dynamics Convair Division	San Diego, CA	Dan Cunha	Yes	No	•
Prime	General Dynamics Convair Division	San Diego, CA	Lee Nottebaum	Yea	Ŷ	1
Prime	General Dynamics Fort Worth	Forth Worth, TX	Richard Clothier	Yea	No	•
Prime	General Dynamics Fort Worth	Forth Worth, TX	John Dukes	Yes	٩N	1
Prime	General Dynamics Fort Worth	Forth Worth, TX	J. Randy McKenzle	Yes	No	1
Prime	General Electric	San Jose, CA	Jack Shukla	No	No	ł
Prime	GM/Delco	Goleta, CA		No	No	1
Prime	Hughes Aircraft / Radar Systems	El Segundo, CA	Tyrone Jackson	Yes	Yes	Үеэ
Prime	Hughes Aircraft / Ground Systems	Fullerton, CA	John Jacobson	Yes	Yea	Yes
Prime	Hughes Aircraft / Space & Comm.	El Segundo, CA	Glenn Caplin	No	٥N	1
Prime	Hughes Santa Barbara Research Center	Goleta, CA	Roy Barncastle	No	No	1
Prime	Lear Siegler Inc.	Santa Monica, CA	Gunner Soderland	No	No	1
Prime	Litton Aeroproducts			Ňo	٥N	ı
Prime	Lockheed	Sunnyvale, CA	Edward Polgar	Yes	٥N	'
Prime	Lockheed	Sunnyvale, CA	Helga Fuller	Yes	Yes	Yes
Prime	Martin Marietta Manned Space Systems	New Orleans, LA	Charles Levy	Yes	Yes	No
Prime	Martin Marietta Manned Space Systems	New Orleans, LA	Joseph Mangino	Yes	Yes	Ŷ
Prime	McDonneli Douglas	Hawthorne, CA	Robert Babin	No	Ŷ	'
Prime	McDonneil Douglas	St. Louis, MO	Robert Carson	No	٥N	'
Prime	McDonnell Douglas		Joseph Benn	Yes	٥N	'
Prime	McDonnell Douglas		Cliff Boehmer	No	No	,
Prime	Northrop Aircraft	Lakewood, CA	Paul Boyle	Ŷ	No	,
Prime	Teledyne Electronics	Newbury Park, CA	William Crowley	No	Ŷ	
Prime	Teledyne Systems	Northridge, CA	John McAulay	Yeə	Үеэ	Yes
USAF	Space Division/SE	El Segundo, CA	Louis Haung	٥N	٥N	ł
USAF	WSMC/SES		William Riley	No	٥N	•
U.S. Navy	Naval Underwater Systems Center	Newport, RI	George McNamara	Yea	Yes	Yes
U.S. Navy	Naval Underwater Systems Center	Newport, RI	Jerry Morris	Yes	Yes	Yea
U.S. Navy	Point Mugu TC	Pt. Mugu, CA	Richard Holst	No	o N	•
U.S. Navy	Point Mugu TC	Pt. Mugu, CA	Irene Hofer	٥N	٩٥	'
U.S. Navy	Point Mugu TC	Pt. Mugu, CA	Dan Kimsey	٥N	No	•
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Table 2-2. Organizations Contacted for the SCA Survey

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Table 2-3. SCA Survey Summary

Area	Number of <u>Respondents</u>	Comments
Procedure: Circuit Partitioning	4	Three perform it manually. One has a fully automated system.
Network Tree Generation	3	Two have manual and computer-aided procedures. One has a fully automated procedure.
Automation Environment	2	One indicated the need for a minicomputer or mainframe. Both indicated that SCA work stations are under development.
Data Entry: Schematics	4	All use manual and computer-aided procedures.
Net Lists	3	All use manual and computer-aided procedures.
Functional Nets	3	All have manual procedures. One has a computer-aided procedure.
Timing Data	3	All have manual procedures. Two have a computer-aided procedure.
<u>Chne Types</u> : Sneak Paths	4	All have manual procedures addressing analog and digital circuits. One has a computer-aided procedure.
Sneak Timing	4	All have manual procedures addressing analog and digital circuits. Two have a computer-aided procedure.
Design Concerns	4	All have manual procedures addressing analog and digital circuits. Two have a computer-aided procedure.
Design Integration: FMECA	5	
Tolerance	4	
Fault Tree	5	
Power & Load	2	(<i>i.e.</i> , trees) to aid the performance of these analyses.
Grounding	2	I
Safety	3	
Application Phase:	5	One respondent has applied SCA prior to Full Scale Engineering Development (FSED). All have applied SCA during FSED.

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The summary table indicates that:

- The current, prevalent procedure for SCA consists of automated formatting and partitioning of schematic and net list data, semi-automatic generation of network trees, and manual application of sneak clues and design concerns.
- Efforts are underway for reducing the requisite computer resources from a mainframe to a workstation.
- Functional networks (block diagrams) are rarely analyzed.
 - The most prevalent types of analyses for which SCA databases and results are shared are FMEA and fault tree analysis.

Conventional SCA techniques are based upon the generation and utilization of network trees. Trees aid the analysis by segmenting the circuitry into small topologically related units, omitting extraneous detail and drawn in a logically consistent manner (power flow from top to bottom, signal flow from left to right). The trees are carefully annotated to facilitate cross-referencing with each other and with the analysis input data (schematics, wire lists, parts lists, *etc.*). Proposals have been made for utilizing the network tree database to support other analyses such as FMEA, fault tree analysis and power loading analysis that require evaluation of circuit topology [CLAR80], [NP3634], [RANK70].

Network trees are difficult to implement because of the complex processing required for their generation. Proprietary, automated algorithms are used for partitioning the circuitry into segments on which the trees are based. This approach may be the only one feasible for thoroughly analyzing an entire set of schematics associated with medium to large systems. These drawings are usually not available until late in the development cycle (*i.e.*, toward the end of Full Scale Engineering Development (FSED) and beyond).

The analysis procedure can be simplified by considering clues that are independent of topology and therefore can be applied without the need for network trees. This approach is particularly applicable to the early phases of a design when detailed circuit data required for generating trees are not available and is the basis for the manual and automated procedures described later in this report.

2.2.3 Related Analyses

As part of the data collection task, information was gathered on reliability analysis techniques that are prospective candidates for integration with SCA. The more widely used of these analyses are FMEA, fault tree analysis, worst case analysis and preliminary hazard analysis. It was observed that activities currently being conducted under the heading of sneak circuit analysis interface with, and partially duplicate, the above analyses and other reliability, safety, and design tasks. The nature of the interface, the data and techniques that may be common, and the allocation of currently duplicated or undefined responsibilities were evaluated during this study.

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In this connection, it is convenient to divide the reliability centered activities into those that relate to operational (non-failed) equipment, those that relate to failed equipment, and those that relate to safety. This division is shown in Table 2-4. A problem in the integration of sneak analysis with all of these is that on a given project there is no certainty that any of the other analyses are being conducted.

Table 2-4. Equipment Concerns of Reliability Analyses

OPERATION	FAILURE	SAFETY			
Worst Case Analysis Component Tolerance Analysis	Failure Modes & Effects Analysis Fault Tree Analysis	Preliminary Hazard Analysis System Hazard Analysis			
Fault Tolerance Analysis	Common Cause Failure Analysis	Operations Hazard Analysis			
Sensitivity Analysis		Fault Hazard Analysis			
Power & Load Analysis		Accident Analysis			
Grounding Analysis					

With respect to FMEA, probably the most widely invoked task of those shown in Table 2-4, there is much latitude in the level of detail that is required to be covered, and therefore uncertainty about the usefulness of close integration with SCA.

A summary description of interfaces between SCA and related analyses is presented in Table 2-5. The greatest potential for duplication (and therefore also for cost reduction) exists between SCA and the operational group of analyses. Worst case and sensitivity analyses cover many of the areas that are included in the design concern analysis part of SCA. Worst case analysis considers system performance when component tolerances and environmental conditions are at their specified extreme limits. Sensitivity analysis evaluates the degree to which system performance is affected by small variations in the values of the system components.

Where compliance with fault tolerance design criteria must be analyzed (MIL-STD-785B, par. 50.2.4.1), this also has an important interface because the criticality of the functions that makes SCA necessary will in most cases also require fault tolerance, and the latter must address the absence of design factors (such as sneak circuits) that can defeat its purpose. Single point failure analysis, an important part of fault tolerance analysis, has significant interfaces with sneak circuit analysis.

Grounding analysis, which is really a design rather than reliability technique, covers one of the most critical parts of SCA, particularly for relay circuits, and coordination of the activities presents an opportunity for substantial cost savings. The analysis addresses the Table 2-5. SCA Interfaces with Reliability Analyses

OVERLAP OTHER	e identification of critical areas	its of improper Identification of intended critical components aquipment	e device oriented Identification of in concerns critical components	nd sneak paths* Identification of critical areas
ARING	ading to None	sulting Effec or un opera rns nodes failed ata	zns Some desig ans ata base	bution Grou
DATA SH	Conditions le failure	Conditions re from failure Design conce Network tree Component d bases	Design conce Timing diagr Component d	Ground distri
TOOL SHARING	Network tree generation	Circuit analysis Logic timing analysis	Circuit analysis Logic timing analysis	Network tree generation
ANALYSIS TYPE	Fault Tree	FMEA	Worst Case, Sensitivity, & Parts Tolerance	Grounding

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* Except floating grounds due to equipment removal.

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possibility of current flow between ground nodes, a condition often associated with sneak circuits. Power and load analysis, another design technique, evaluates open circuit voltages and short circuit currents on lines controlling hazardous functions.

With regard to the failed equipment analyses, the most important interfaces exist with fault tree and failure modes and effects analysis. Fault tree analysis is a "top-down", deductive procedure for identifying causes of system failures. The analysis utilizes diagrams referred to as fault trees for depicting the dependency of higher level failure events on lower level events. Common cause failure analysis is a similar top-down procedure that identifies single failure events caused by the occurrence of multiple events. The analyses, where they are being conducted, can be used to identify the functions and components to be subjected to SCA. By narrowing the scope of the latter, substantial cost savings are possible.

Failure modes and effects analysis (FMEA) shares important techniques with sneak circuit analysis, including the use of network trees. FMEA is a "bottom-up" procedure for inferring the higher level effects of postulated, lower level failures. The effects may be used as a baseline for an extended SCA where the analysis is required to identify sneak circuits in the presence of one or more faults. Here, a sneak circuit can compound the effects and increase the criticality level. Also, some of the effects of failures may be duplicated by improper or unintended operation of non-failed equipment. Thus sharing of data may be beneficial. Where fault tree analysis is not being conducted, the components associated with catastrophic and major failures in FMEA can be used as a candidate list for SCA. It is important to realize that FMEA is frequently a basis for the design of built-in test and operational test equipment and for maintenance and logistics activities. It is thus a primary task under MIL-STD-785B that should not be made dependent on the results of SCA.

Safety analyses include the preliminary hazard analysis for evaluating potential hazards early in the system design, system hazard analysis for identifying hazards later during system development, operation hazard analysis addressing hazards associated with fielded equipment, fault hazard analysis for identifying potential hazards caused by component failures, and accident analysis. The sharing of data and techniques with safety related activities may be deliberately restricted in order to keep safety activities for highly critical equipment independent of reliability and design. However, in other cases information sharing may be permissible and should then be encouraged in order to contain costs.

2.3 A Simplified Manual Procedure

The manual SCA procedure developed during this study is a simplified version of the conventional procedure. It is intended for use by the design engineer or reliability analyst as a means for both avoiding designs likely to contain sneak paths and for identifying most instances where sneak paths exist. It is not intended as a substitute for the conventional procedure applied to a fully developed system but instead serves as a simplified method for minimizing the number occurrences of sneak conditions early in the design effort.

The procedure was developed by compiling sneak clues from several sources (see section 2.2.1), selecting clues most relevant to identifying sneak problems, and generating a concise yet thorough guide for their application. The guidelines resulting from this effort are categorized as follows:

- 1. Design rules for an engineer to follow early during development to avoid designing circuits prone to sneak conditions.
- 2. Functional guidelines for an engineer or reliability analyst to identify sneak conditions appearing in power distribution circuits, power and signal timing, and status indicator circuits.
- 3. *Device guidelines* for an engineer or reliability analyst to identify sneak conditions caused by circuit devices including relays, transistors, and linear and digital integrated circuits.

Each design rule and guideline contains a brief statement of the problem being identified, a recommended solution, a supplementary paragraph describing the problem in greater detail, and an illustration of the problem and solution. The guidelines also include a descriptor for categorizing the targeted circuitry.

The design rules are the most cost-effective of the three items for addressing sneak problems during design and for this reason are emphasized by the procedure. It is far easier and less costly to avoid sneak circuits through proper design techniques than to identify and correct sneak circuits after the design has been completed.

While the design rules are intended for an engineer responsible for circuit design, the functional and device guidelines are intended for either an engineer or an analyst familiar with the operation of the circuitry and its constituent devices. The functional guidelines may be applied before specific circuit device types have been finalized. Their application requires a diagram depicting power distribution at the assembly (*e.g.*, printed circuit board) level and identification of analog or digital and high or low current areas of the circuitry. The device guidelines are applied after circuit devices have been selected for the lesign. The selection need only be generic (*e.g.*, NPN bipolar transistor, low power Schottky TTL digital counter); specific part numbers are not necessary. For complex systems, application of the guidelines should be focused on circuitry associated with critical system functions rather than the entire system. Critical functions may be identified by fault tree analysis or FMEA.

The manual procedure is documented in a report titled Sneak Circuit Analysis for the Common Man (report number RADC-TR-89-223) generated as a part of this study. An example of a design rule appears in Figure 2-2, and an example of a guideline appears in Figure 2-3.



PROBLEM: Sneak paths involving multiple power sources and/or multiple ground returns.

SOLUTION: Structure circuits so that all current for a given load flows from one power source to one ground return. Where this is not possible, isolate power sources using diodes for DC power or relays (electromechanical or solid-state) for AC or DC power. Use Schottky diodes or relays for DC applications requiring very low voltage drop and power dissipation. Isolate returns by separating high and low current loads.



Figure 3. MULTIPLE POWER SOURCES AND RETURNS

Adherence to this rule avoids "Y," "X" and "H" circuit patterns associated with multiple power sources and sinks (see Chapter 2). This is a general rule to be followed wherever possible. An example of a network complying with this rule appears in Figure 3A, and an example of a network violating it appears in part B of the figure. The violations shown can result in power-to-power or ground-to-ground ties. Isolation must be provided to avoid the mixing of low current and high current ground returns. Examples are shown in parts C and D of the figure.

Figure 2-2. Design Rule Example





Chapter 3 AUTOMATED SCA

This chapter describes the development and operation of a simplified, automated SCA procedure developed during this study. The intent of developing this procedure was to demonstrate the concept and feasibility of integrating an SCA tool with an automated design tool to provide a simple yet effective sneak analysis procedure. To this end, the procedure and the automated SCAT supporting it were constrained to a specific input domain (*i.e.*, a net list comprising circuit device types from a specified parts library and formatted in a specified manner) and to a subset of sneak clues (*i.e.*, those associated with commonly encountered sneak conditions). However, the procedure can readily be extended to apply to a wider variety of input data and check for a larger number of conditions.

3.1 Overview

SCAT is a microcomputer based expert system for automatically identifying sneak paths and design concerns by processing circuit net lists generated by a CAD schematic capture tool. SCAT differs from conventional SCA techniques in that the latter are based upon the generation (usually automated) and analysis (mostly manual) of network trees to identify sneak paths. The proposed tool does not require network trees; in fact, it is particularly applicable to early phases of a design when detailed circuit data required for generating trees are not available.

The automated procedure provides the design engineer or reliability analyst with a simple tool for rapidly identifying and correcting sneak circuits and relevant design concerns. Identification of topological patterns is not required. Sneak paths are automatically identified for power switching circuitry. Design concerns relevant to sneak circuits are identified for analog or digital circuits. The procedure focuses the analysis on portions of the circuitry for which the analyst has design responsibility (or detailed understanding of its operation), *e.g.*, a circuit card assembly or a subsystem such as power distribution. A more extensive analysis would require application of a conventional SCA. However, even in this case, prior use of the proposed procedure would minimize the number of remaining sneaks and thereby greatly reduce the cost impact and other concerns associated with correcting problems late in the design phase.

The automated procedure is based in part on the fact that sneak paths involve circuit branches that can conduct current in either direction depending upon the switching state of the circuit. SCAT searches for these bidirectional branches rather than perform the more complex task of searching for specific topological circuit patterns as done by conventional automated SCA techniques. The analyst's task is also reduced to evaluating the significance of specific sneak paths rather than applying "clue lists" to circuit patterns for identifying the sneak paths. A significant issue that arises in regard to focusing the analysis at any one time to a portion of the system is the assurance that sneak paths associated with assembly or subsystem interfaces are not overlooked. This issue is addressed in two ways. First, the system compels the user to identify each interface port of a switching circuit in terms of it being a power input, ground return, or signal I/O. Interfaces to power and ground are labeled as such regardless of whether they respectively go to power and ground directly or through switched or unswitched loads, and they are included within the sneak path search. Second, the SCAT is intended to identify many (but not necessarily all) sneak conditions early in the design when interfaces may not yet be completely defined. In this manner, problems can be corrected early at minimal cost so that at a later development phase a more conventional SCA can be performed on the entire system and uncover the few, if any, remaining problems.

3.2 Description

The automated procedure comprises four major tasks:

- 1. Schematic capture/net list generation.
- 2. Sneak path analysis.
- 3. Functionally oriented design concern analysis.
- 4. Device oriented design concern analysis.

These tasks have been computerized utilizing a concurrent engineering environment comprising a commercial schematic capture product and the expert system based SCAT. Schematic capture and net list generation are performed by OrCAD/SDT III version 3.21 or later release. It is available through OrCAD Systems Corp., Hillsboro, Oregon.

The sneak path and design concern analyses are performed by the SCAT expert system, developed from an M.1 (Teknowledge, Inc.) expert system shell. The shell consists of the M.1 inference engine and facilities for developing and maintaining the SCAT knowledge base. M.1 was selected from among eleven, commercially available, MS-DOS based shells evaluated for the SCAT application. M.1 was selected because of its execution speed (the shell is coded in C rather than LISP which is used by many others), its rich repertory of syntactical functions (e.g., pattern-matched variables, a facility for rule looping, and a large number of built-in meta-facts and meta-propositions), and its open knowledge base (the rules are formatted in ASCII text).

The SCAT knowledge base consists of approximately 265 rules stored in nine data files. The knowledge base is augmented by approximately 650 lines of C source code implementing those portions of the analysis requiring intensive processing. These portions include reading the EDIF net list and performing the sneak path search. The code was developed on Microsoft's QuickC environment and C 5.0 Optimizing Compiler. Information needed for maintaining the program, including extensively documented source code and knowledge base files, appears in Volume II of this report. To maintain an audit trail, each file is prefaced by a header identifying the date of the last revision, its originator, and a brief description of it.

A functional diagram of the system appears in Figure 3-1. Prior to running SCAT, the user must generate a net list of the circuit to be analyzed using the OrCAD schematic capture program. The net list must be saved either on hard disk or floppy disk. SCAT reads and processes the net list, as directed by the user, to identify sneak paths and design concerns. Utilizing the user friendly, consultation type interface provided by the SCAT expert system, the user must specify the name of the net list file and the type of analysis to be performed (sneak path or design concern). For the sneak path analysis, the user must confirm that suspicious paths identified by SCAT are in fact sneak circuits (i.e., they inhibit desired functions or cause undesired outputs). The expert system provides assistance for this task. For the design concern analysis, the user must respond to prompts regarding technical details of the circuit under analysis. Assistance for this is available in the form of "help" messages. Explanations and possible solutions for identified design concerns are also available. Operational details, program limitations, and an example of the procedure are provided by the user's manual in an Appendix A of this report. Α general description of the major tasks involved in the procedure is presented next.



Figure 3-1. Computer Aided System for Sneak Analysis

3.2.1 Schematic Capture/Net List Generation

The automated procedure requires that the circuit under analysis be captured and formatted by CrCAD/SDT III. A schematic is captured by drawing it on the screen using the various graphics and text editing features and the device symbol libraries provided by the program. All interfaces involving power and ground, whether direct from external sources or from external switches/drivers must be labeled using the OrCAD "module port" function (an option provided by the program for designating signal terminations). This will enable SCAT to account for all significant interfaces to portions of the system not under analysis. In addition, the terminals of all internal power sources (*e.g.*, on-board batteries) must be similarly labeled to address potential sneaks involving power-to-power ties. After capturing the schematic, the net list is generated and saved using the OrCAD "FlatEDIF" utility. When invoked by the user, this utility translates the captured schematic into an ASCII text file conforming to the Electronic Industries Association (EIA) Interim Standard No. 44 for EDIF version 1 1 0³.

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3.2.2 Sneak Path Analysis

After generating the net list, the user enters SCAT and specifies the name of the net list file to be processed. The user is then given the option of performing a sneak path analysis or the design concern analyses. The following discussion assumes the former has been selected.

Sneak path analysis is performed on power switching circuitry, *i.e.*, circuits involving combinations of current interruption devices such as switches, relays, fuses, connectors, and transistors. During the analysis, all possible non-cyclic (*i.e.*, non-intersecting), directed paths are automatically identified between every pair of power and power return points in the circuit (herein after referred to as the *source* node and *sink* node) specified by the user. To facilitate this path search, SCAT automatically models the following types of devices:

- Switch and relay contact arrangements (single and multiple pole/throw, breakbefore-make and make-before-break).
- Transistors (both bipolar and MOS) and diodes.
- Capacitors (under conditions of both AC and DC current flow).
- Other two-terminal passive devices (resistors, inductors, *etc.*).
- Multi-terminal passive devices (transformers, potentiometers, *etc.*).

The user may override (either globally or for specific devices) the default model assumed for switch and relay contact timing (break-before-make) and for capacitors (open circuit).

³The more recent version, 2 0 0, was not available in time for this effort.

Connections to integrated circuits are modeled as open circuits since paths are not traced through these devices.

Following the path search, path sets are identified in which a common branch conducts current in both directions. These bidirectional branches are usually indicative of an undesired reverse current path, the distinguishing feature of a sneak circuit. Each reverse current path is displayed as a list of schematic reference designators of the devices that appear along the path, listed in the order of their appearance between the source node and sink node. Once identified, the user must confirm the validity of the path by considering operational constraints that may preclude certain switching states assumed by the path in question. In addition, their potential impact on system operation must be evaluated. The SCAT expert system provides guidance for these evaluations to the less experienced user. The guidance is in form of prompts regarding the location of critical loads and the timing of switches affecting the path.

An example of a reverse current path identified by SCAT is shown by the schematic in Figure 3-2. The circuit is a simplified version of the infamous Redstone missile/blockhouse interface that caused premature engine cutoff a few seconds after launch. The cause was determined to be the sneak path, highlighted on the schematic, between the launch command and engine cutoff relays that occurred when the ground umbilical separated a fraction of a second before the separate power umbilical. The net list for this schematic was processed by SCAT, and the resulting screen corresponding to the reverse current path is shown in Figure 3-3. The path is identified by the part reference designators appearing in the schematic.

3.2.3 Functionally Oriented Design Concern Analysis

Functionally oriented design concerns address the following types of sneak conditions:

- power-to-power ties.
- inadvertent load power cutoff by logically AND'd switching devices.
- inadvertent load power enabling by logically OR'd switching devices.
- improper timing for power enabling and power cutoff.
- misleading indications and labels.

More than serving as clues for the analyst, these concerns compose a knowledge base of rules that are evaluated by SCAT with respect to the specific circuit being analyzed. In this manner, non-relevant clues are filtered, and wherever possible the user is directed to specific areas of the circuit under concern. As an example, consider the power-to-power tie highlighted in the schematic of Figure 3-4. The circuit is a portion of the FB111(A)B Pivot Pylon Weapon Station Circuitry that underwent a conventional SCA circa 1975 [BOEI75]. The power tie was identified by SCAT as shown by the screen in Figure 3-5. As shown in Figure 3-6, the user is also offered assistance by way of an explanation message and a possible solution. These aids are directed toward less experienced users.



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Figure 3-2. Reverse Current Path in Missile Launch Circuit

ADDI TOATION DIODIAN	
[reds.net] src to snk reverse current path 1 path ref. number: 1	of 9:
[K4-S,P30,P19,P1,P2,P18,LP6,*K1-C,*P15,*P6,* NOTE: Asterisk (*) indicates a reverse curre	P5,*P21,*P31,L2] ent device.
Deleted Parallel Parts: []. Deleted Switch Related Parts: []. Deleted Miscellaneous Parts: [].	
Usc	up/down arrows to scroll answers.
	up/down arrows to scroll answers.
QUESTION	ANSWER
Use QUESTION Choose: - Display Next Path - Display Previous Path - Analyze Current Path	ANSWER DEXIL, previous analyze
Use QUESTION Choose: - Display Next Path - Display Previous Path - Analyze Current Path - Delete Current Path	ANSWER next previous analyze delete
Use QUESTION Choose: - Display Next Path - Display Previous Path - Analyze Current Path - Delete Current Path - Print Path	ANSWER next previous analyze delete print
QUESTION Choose: - Display Next Path - Display Previous Path - Analyze Current Path - Delete Current Path - Print Path - Return to Menu	ANSWER previous analyze delete print return
Use QUESTION Choose: - Display Next Path - Display Previous Path - Analyze Current Path - Delete Current Path - Print Path - Return to Menu	ANSWER previous analyze delete print return Space to Mark




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APPLICATION DISPLAY-	
Warn ing :	
Check for possible power-to-power tie betw when switching devices are closed. The sy following devices: path(1) = [CB2,P49,P50,K4,P23,P18]	ween ess_28vdc and x_28vdc_mau_fire1 neak path(s) comprises the
QUESTION	
	explanation solution warning_message
	return unknown
	I Supporte Mark
ALT-A Abort F2 Scroll Display F10 Cor Figure 3-5. SCAT PC	owand Menu REAL
ALT-A Abort F2 Scroll Display F10 Cor Figure 3-5. SCAT PC M1 Commands APPLICATION DISPLAY A power-to-power tie between supplies can supplies or to the load. This problem can supplies are connected to a common load th -pg17	result in damage to the n arise if primary and backup hrough a make-before-break switch.
ALT-A Abort F2 Scroll Display F10 Con Figure 3-5. SCAT PC M1 Commands APPLICATION DISPLAY A power-to-power tie between supplies can supplies or to the load. This problem can supplies are connected to a common load th -pg17 - For DC power, add diodes to isolate the diodes can be used to minimize the diode - For AC (or as an alternative for DC) use or switch having a break-before-make con select either supply, and provide adequa load to maintain the supply voltage duri	result in damage to the n arise if primary and backup brough a make-before-break switch. supplies. Schottky e voltage drop. e a double-throw relay ntact arrangement to ate capacitance at the ing switch-over.
ALT-A Abort F2 Scroll Display F10 Cor Figure 3-5. SCAT PC A power-to-power tie between supplies can supplies or to the load. This problem can supplies are connected to a common load th -pg17 - For DC power, add diodes to isolate the diodes can be used to minimize the diode - For AC (or as an alternative for DC) use or switch having a break-before-make con select either supply, and provide adequa load to maintain the supply voltage duri - WESTION- Choose one of the following options:	result in damage to the n arise if primary and backup hrough a make-before-break switch. supplies. Schottky e voltage drop. e a double-throw relay ntact arrangement to ate capacitance at the ing switch-over.
ALT-A Abort F2 Scroll Display F10 Con Figure 3-5. SCAT PC A power-to-power tie between supplies can supplies or to the load. This problem can supplies are connected to a common load th -pg17 - For DC power, add diodes to isolate the diodes can be used to minimize the diode - For AC (or as an alternative for DC) use or switch having a break-before-make con select either supply, and provide adequa load to maintain the supply voltage dur QUESTION— Choose one of the following options:	
ALT-A Abort F2 Scroll Display F10 Con Figure 3-5. SCAT PC M1 Commands APPLICATION DISPLAY A power-to-power tie between supplies can supplies or to the load. This problem can supplies are connected to a common load th -pg17 - For DC power, add diodes to isolate the diodes can be used to minimize the diode - For AC (or as an alternative for DC) use or switch having a break-before-make con select either supply, and provide adequa load to maintain the supply voltage dur QUESTION Choose one of the following options:	ANSWER ANSWER ANSWER ANSWER ANSWER ANSWER ANSWER ANSWER Continue explanation solution warning_message return unknown

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3.2.4 Device Oriented Design Concern Analysis

Device oriented design concerns address sneak related problems associated with specific analog and digital devices appearing in the net list. Concerns covered by the analysis include:

- Reverse current paths through bipolar transistors.
- Reverse current paths through op-amp summing junctions.
- Sneaks caused by noise sensitive devices.
- Relay suppression problems.
- Interface problems at the input and output of digital devices.

As was the case for the functional concerns, the analysis was automated by translating each concern into a set of rules for the expert system knowledge base. SCAT checks each device in the net list against these rules, querying the user for additional information regarding the devices whenever conclusions cannot be drawn based solely upon data contained in the net list. The user interface is identical to the functionally oriented concerns in that separate display windows are provided for queries, user response menus, and results. Circuit components are referenced by their schematic designations, and an explanation or solution can be requested for each identified concern.

An example of a design concern appears in Figure 3-7. As seen in the figure, a sneak current can flow from signal generator, through the base to collector junction of the NPN bipolar transistor, and into load X1 when collector power V_{cc} is removed by opening switch S1. The corresponding SCAT message identifying this concern appears in Figure 3-8. Note that the subject of the concern is identified in the warning message by its schematic designation, and that the user has the option of requesting an explanation or solution in addition to the original warning message.

3.3 Test Results

The performance of the automated procedure was characterized by processing net lists seeded with sneak problems to (1) determine whether all sneak conditions were identified, (2) determine if any non-sneak conditions were identified, and (3) measure the time required for performing the analysis. The first two items were evaluated by applying SCAT to various circuits seeded with a known set of sneaks. Time measurements were only for sneak path searches; design concern analyses are heavily user interactive and any time measurements would inevitably be affected by the specific design concerns identified and the response time of the user. In general, design concern screens are updated 1 to 10 seconds after user input, depending upon the number of concerns the system tests prior to displaying the next screen, the complexity of the schematic being evaluated, and the speed of the computer used to run the program. User input typically requires under five seconds for data entry. For the sneak path search, elapsed time was measured from user entry of the path search execute command rather than SCAT startup so as to not include the length of the user interactive startup session.

Signal Generator Power Signal Generator Q1 E T

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Figure 3-7. Transistor Reverse Current Sneak

There may be a sneak path from the base of the transistor(through the forward biased base-collector junction, to the	s) [q1]
10au.	collector
Choose one of the following options: continue explanation	n
solution warning_m	essage
unknown Snace to	Mark

Figure 3-8. Transistor Sneak Display

Results for three test cases appear in Table 3-1. Case 1 (Figure 3-9) was extracted from an actual application of avionics switching circuitry in order to test a representative circuit topography (*i.e.*, realistic ratios of nodes to branches and of series branches to parallel branches). Cases 2 and 3 (Figures 3-10 and 3-11) were created by, respectively, doubling and quadrupling Case 1 and adding a bidirectional branch where before there was none. The net lists corresponding to these cases were analyzed by running SCAT on two different host computers; an 80286-based and an 80386-based machine, configured without math co-processors. The resulting path search times ranged from 15 seconds (smallest circuit, fastest computer) to 85 seconds (largest circuit, slowest computer).

The procedure's effectiveness, as defined by the first two points in the previous paragraph, was tested by analyzing topologically circuitry having no reverse current paths (Case I) as well as circuitry with above average numbers of such paths (Case II and III). In all cases, all seeded reverse current paths were found and no path was mis-identified as being a reverse current path.

.

μP	Computer RAM	Clock	Perf. Ratio*	Test Case	Reverse Paths**	Search Time
'286	640 KB	10 MHz	11.5	 	0/0 4/4 8/8	20 s 35 s 85 s
'386	1 MB	16 MHz	18	 	0/0 4/4 8/8	15 s 25 s 50 s

Performance compared to standard IBM-PC. Seeded paths/identified paths *

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Figure 3-9. Test Case I



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Chapter 4 CONTROL AND MONITORING OF SCA

A major objective of this study was to develop control and monitoring procedures for evaluating the effectiveness of an SCA effort. Four areas were investigated in this regard:

- 1. <u>Sneak report follow-up procedures.</u> These serve as a procedural control for assuring that problems identified by sneak circuit analysis are considered (but not necessarily acted on) by those responsible for the design.
- 2. <u>SCA effectiveness accounting.</u> This reporting area is intended to capture the impact of sneak analyses on design by measuring the number and significance of changes that are implemented as a result of SCA.
- 3. <u>Thoroughness monitoring</u>. To measure the quality and thoroughness of sneak circuit procedures, the number of pertinent sneak problems found by other techniques are compared with the number of problems of equal severity that are found by SCA.
- 4. <u>Cost-effectiveness studies.</u> The resources required to find a problem of a given severity level by SCA is compared to the resources required to find an equally severe problem by other techniques.

The investigative approach for these areas was based upon analyzing existing government and contractor requirements for identification and documentation of sneaks identified as part of a sneak circuit analysis. The investigation encompassed an evaluation of (1) military standards, (2) associated Data Items Descriptions (DIDs) and (3) previous studies directed at sneak circuit analysis. SCA contractors have their individual internal policies and procedures for performing SCA and tracking resultant identified sneaks. This complicated the study since contractor procedures could not be obtained. The experiences of the investigators were utilized to overcome this problem.

4.1 Background

Overall reliability programs for government procurements and for which sneak circuit analysis may be a part are generally conducted in accordance with MIL-STD-785B. Reliability program reviews are required by Task 103 of the standard. This task permits the contractor and the Program Authority $(PA)^4$ to review overall program status (including

⁴ The Program Authority is the responsible government representative for specific program discipline (Program Management, Reliability, System Safety, Engineering, etc.).

SCA). The corresponding DID, DI-R-7080, Reliability Status Report, is used to monitor and evaluate a contractor's progress and accomplishments in conducting the reliability program for the applicable contract end item(s).

SCA is generally conducted by the reliability or safety organization within a project team and is performed in accordance with Task 205 of MIL-STD-785B. Sneak analysis activity is reported via DID DI-R-7083, Sneak Circuit Analysis Report. The DID is invoked for periodic reporting on the status of all current and previously submitted problem reports (*i.e.*, Sneak Circuit Report, Design Concern Report, Documentation Error Report, all of which are in the contractor's own format) and for a final report summarizing the results at the conclusion of the SCA..

Conventional SCA is based on detailed system drawings and computer programs. These data may be available late in program Demonstration/Validation Phase but would more likely be available late in the Full Scale Development Phase. Consequently, resultant data from DI-R-7083 may or may not be available at significant program decision-making milestones.

Sneak report monitoring by the PA depends to a great degree on each contractor's reporting and tracking process and, to a greater degree, on the contract statement of work requirements. In general, identified sneaks must be validated and tracked by the contractor to disposition. Some examples of sneak disposition include no action, system redesign or follow-on modification. Once verified, sneak reports gain increased visibility. Those with severe safety or equipment damage impacts are most visible and evoke PA involvement.

4.2 Recommended Procedures

4.2.1 SCA Follow-up

The SOW should require the contractor to track all identified sneaks through to disposition and to provide resultant data to the PA. In order to maintain proper system baseline control, the contractor may present the identified sneaks to various review panels and boards. The PA should attend even the informal reviews in order to monitor progress and to provide the customer viewpoint when appropriate. The status of all identified sneaks should be required at key program milestones for the PA to assess overall reliability program progress. Recommended milestones are Critical Design Review (CDR), Functional Configuration Audit (FCA) and DD Form 250 sign off.

4.2.2 SCA Effectiveness

This study considers SCA effectiveness to be a measure of the number of identified sneaks related to the number of resultant design changes implemented. In order to analyze and measure this effectiveness on one program or across many programs, data must be available which support such an analysis. It should be noted that relevant SCA data collection was also recommended in a study completed in 1982 by Boeing Aerospace

Company. In part, it stated that "A major element missing from this (Boeing) effort which could be considered in measuring effectiveness is a method to track the resulting dispositions for the Sneak Analysis Reports." The report went on to say that only by collecting relevant data could SCA effectiveness be measured.

In order for the PA to assess SCA effectiveness, all sneaks must be tracked from identification through resolution and disposition. Collection of tracking data depends on requirements in the contract Statement of Work (SOW) since there is no DID associated with a monitor and track task. DI-R-7083 contains general information regarding the SCA Report content with no specific instructions with regard to items of interest to the PA.

Data collection regarding each identified sneak should logically be performed by the contractor. These data include elements such as sneak type category, nature of the sneak, sneak severity category, disposition and manhours and costs to implement design changes. A weighting factor, based on the sneak severity category, should be applied to weigh the relative significance of each identified sneak.

4.2.3 SCA Cost-Effectiveness

Relevant data for analyzing cost effectiveness are not generally available. In addition to SCA data submitted by the contractor, two cost data elements must be added by the PA before a meaningful analysis is possible. These elements are (1) total contract cost to perform the SCA, and (2) total program cost. Additional comments such as the size of the system under acquisition should also be included. Ideally, the information would be compiled in a relational database to facilitate retrieval for cost-effectiveness analysis. A relational database is recommended since it provides the required link between significant data files such as contractor, analysis size and cost.

SCA cost-effectiveness addresses the relationship between the cost of performing SCA, costs associated with correcting sneak problems, and costs associated with other reliability analyses such as FMEA, Fault Tree, Worst Case, Finite State Machine (*e.g.*, analyses utilizing Markov models or Petri net diagrams) which seek to identify deficiencies prior to integration and test. Cost data for these other analyses should be provided by the PA for inclusion in a database. The data are used to perform the following analyses:

- 1. Compare the cost of the SCA with the cost of removing the sneak circuit by other means.
- 2. Compare the cost of the SCA with the cost of the failure that would occur if the sneak circuit was not found.

4.2.4 SCA Thoroughness

SCA thoroughness is a measure of the type and quantity of sneaks identified as a result of analyses other than SCA. This measure is appropriate when other analyses are performed

on a system whether or not a SCA is performed. Other analyses might include Failure Mode, Effects Analysis, Fault Tree Analysis, Common Cause Failure Analysis, Sensitivity Analysis, Worst Case Analysis, Power and Load Analysis, Grounding Analysis, Finite State Machine Analysis, Preliminary Hazard Analysis, Desk Checking and Peer Code Review. To measure SCA thoroughness in this context, the same data categories are required from the analysis contractor as is noted above for SCA effectiveness.

4.3 Proposed Data Items

Implicit in this investigation was an implementation of the recommended procedures using the most cost-effective methods possible with minimal impact on contract requirements. Toward this end, the preferred approach to obtain data was to modify existing DIDs in lieu of creating new DIDs. The affected DIDs are DI-R-7083 and DI-R-7080. The DIDs and the proposed changes to them are presented in Appendices B and C. A discussion of these changes is presented in the following paragraphs.

4.3.1 Modifications to DI-R-7083 (Ref. Appendix B)

MIL-STD-785B, Task 205, requires the contractor to present results of SCA. DI-R-7083 is the applicable DID for delivering data under Task 205. By modifying DI-R-7083, the PA will obtain SCA data which support existing system acquisitions and will contribute to a database which will support future system acquisitions. Rationale for each change is as follows:

<u>Block 3. Description/Purpose.</u> The overall rewrite of Block 3 is recommended for clarity. Changes point out that details of system design deficiencies assist the PA in evaluating the SCA. SCA overview data, provided in a concise table format, provides the PA with a means to identify areas of concern. The PA will find that the resultant SCA data support design reviews and audits as well as system status determination at DD form 250 sign off.

<u>Block 7, Application/Interrelationship.</u> The rewrite of Block 7 provides the PA with additional guidance for applying this DID. It also points out how the additional data may be used (*i.e.*, determine cost-effectiveness).

<u>Block 10, Preparation Instructions.</u> Block 10 was rewritten to incorporate requirements for those significant data elements which may be used by the PA to monitor and track sneak reports, measure SCA effectiveness and determine SCA cost-effectiveness.

4.3.2 Modifications to DI-R-7080 (Ref. Appendix C)

MIL-STD-785B, Task 103, requires the contractor to present an overview of the reliability program at designated program reviews. DI-R-7080 is the applicable DID for delivering data under Task 103. By incorporating the proposed modifications to DI-R-7080, the PA will obtain reliability data which not only support existing system acquisitions but which

will also contribute to a database to support future system acquisitions. These data will specifically support comparative analyses of analytical tox is and tests (including SCA) applied to program acquisitions. Since analyses and tests are better suited to some applications than others, gathering data on analytical tools, tests, applications and results will, over time, provide the foundation for improving system acquisitions. Rationale for each proposed changes to the DID are as follows:

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<u>Block 10, Preparation Instructions.</u> The change to Block 10 only affects paragraph 1.c. The change is intended to expand visibility into the overall Reliability program report presented at program reviews The last item on the original list (1.c.(7)) is relocated to 1.c.(2) (c) in the revised DID.

4.4 Automating SCA Evaluation

A valuable tool for future program acquisitions is the knowledge and experience gained from past programs. The control and monitoring study has dealt primarily with sneak circuit analysis and its impact on program acquisition. Data gathered as part of SCA, as well as other analyses and various testing methods, could contribute to a database which would provide program managers with insight into costs and benefits of analyses and tests on past programs. This insight, then, becomes a valuable tool which may be used to determine and apply the right analysis and test on future acquisitions.

In order to implement this process, a database must be developed which contains relevant data. Two types of data are required, and each should be maintained within its own file. The first file (File #1) contains program data consisting of information about programs and their significant milestones. The second file (File #2) contains analysis and test data and problems identified with their performance.

The goal is to have a database linking these two files such that program data can be related to analysis and test data and their identified problem areas. The significance of having two files is simply that the data sources for these files are different. Program data are available at the government's program office and analysis/test data are available with the contractor's reliability organization. Since the contractor will likely be required to submit the analysis and test data on a regular basis, this data will be available for inclusion in the database file. The two database files are described below.

4.4.1 Database File #1, Vehicle/System/Application File

This file contains data pertinent to acquisition programs which may range from major weapon systems to small modifications. Relevant data are program costs and milestone dates. Figure 4-1 below suggests pertinent data fields within file records. Detailed information about record fields in File #1 follow.

FILE #1. VEHICLE OR APPLICATION SYSTEM FILE
FIELD DATA
1. VEHICLE OR APPLICATION
2. DESIGNATOR
3. PROGRAM COST
4. CONTRACT COST FOR EACH ANALYSIS AND TEST
5. PROGRAM MILESTONE DATE FOR DEMONSTRATION/VALIDATION PHASE START
6. PROGRAM MILESTONE DATE FOR FULL SCALE DEVELOPMENT PHASE START
7. PROGRAM MILESTONE DATE FOR PRODUCTION PHASE START
8. PROGRAM MILESTONE DATE FOR IOC
9. PROGRAM MILESTONE DATE FOR PRELIMINARY DESIGN REVIEW
10. PROGRAM MILESTONE DATE FOR CRITICAL DESIGN REVIEW
11. PROGRAM MILESTONE DATE FOR FUNCTIONAL CONFIGURATION AUDIT
12. PROGRAM MILESTONE DATE FOR PHYSICAL CONFIGURATION AUDIT
13. PROGRAM MILESTONE DATE FOR FORMAL QUALIFICATION REVIEW

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Figure 4-1. Vehicle or Application System File

<u>Field 1, Vehicle or Application.</u> This field contains information about the top level acquisition program. This could be an aircraft (manned or unmanned, fixed or rotary wing), a satellite, a launch vehicle, ground systems, a new avionics or communications suite, a computer or even a circuit board. This field should contain the highest level title of the acquisition program or project.

<u>Field 2, Designator.</u> This field contains the program designator for the vehicle or application in field 1. Using the examples above this could be B-2, BQM-126A or AH-64A (aircraft), DSCS-3 (spacecraft), Titan 4 (launch vehicle), OTH-B (ground systems), AN/ALQ-172 (avionics). Computer and circuit board could be listed by part number.

Field 3, Program Cost. This field contains the funded cost of the program. This should reflect costs up to but not including production costs.

<u>Field 4. Contract Cost for Each Analysis and Test.</u> This field, which may require multiple subfields, contains the contract line item cost for and title of each analysis and test. If cost data are not available, the field could be left blank. When sufficient data on similar analyses or tests are contained within the database, RADC could determine the percent of program costs expended on analyses and test and then estimate values for each blank subfield to complete each record.

<u>Fields 5 - 13, Program Milestone Dates.</u> These fields initially contain scheduled dates and should be updated with actual milestone dates.

4.4.2 Database File #2, Analysis/Test File

This file contains data related to problems identified during analysis and test. The two common fields linking it with File #1 are the Vehicle or Application field and the program

Designator field. Remaining fields in File #2 contain analysis or test data as well as data to identify key functional systems. Data used to develop this file are contained in DI-R-7080 as modified by this study. Figure 4-2 below identifies pertinent fields in each Analysis/Test record. Detailed information about record fields in File #2 follow.

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<u>FILI</u>	E #2. ANALYSIS/TEST SUMMARY FILE
FIELD	DATA
1.	VEHICLE OR APPLICATION
2.	DESIGNATOR
3.	TYPE OF ANALYSIS OR TEST
4.	DATE PROBLEM IDENTIFIED
5.	TITLE OF PROBLEM REPORT
6.	VEHICLE OR APPLICATION SYSTEM
7.	VEHICLE OR APPLICATION SUBSYSTEM
8.	HARDWARE OR SOFTWARE
9.	HAZARD CATEGORY
10.	DISPOSITION
11.	MANHOURS TO CORRECT PROBLEM
12.	COST TO CORRECT PROBLEM

Figure 4-2. Analysis and Test Data File

<u>Field 1, Vehicle or Application.</u> This field contains information about the top level acquisition program. This could be an aircraft (manned or unmanned, fixed or rotary wing), a satellite, a launch vehicle, ground systems, a new avionics or communications suite, a computer or even a circuit board. This field should contain the highest level title of the acquisition program or project.

<u>Field 2. Designator.</u> This field contains the program designator for the vehicle or application in field 1. Using the examples above this could be B-2, BQM-126A or AH-64A (aircraft), DSCS-3 (spacecraft), Titan 4 (launch vehicle), OTH-B (ground systems), AN/ALQ-172 (avionics). Computer and circuit board could be listed by part number.

<u>Field 3. Type of Analysis or Test.</u> This field contains the type of analysis or test performed which identified the problem. Examples are: Sneak Circuit Analysis, Fault Tree Analysis, Finite State Machine Analysis, Peer Code Review, Burn In Test, etc.

<u>Field 4. Date Problem Identified.</u> This is the date recorded on the problem report and submitted through DI-R-7080. This data field is significant since it is easily plotted against program milestone dates in File #1. This allows analysts to pinpoint precisely when, during program acquisition, each problem was identified.

Field 5, Title of Problem Report. This should be the same title entered on the problem report and submitted through DI-R-7080.

<u>Field 6, Vehicle or Application System.</u> This is the higher level system within the vehicle or application identified in field 1. Inertial Navigation System, for example, is a high level system within the vehicle F-111.

<u>Field 7, Vehicle or Application Subsystem.</u> This is the subsystem within the system identified in field 6. In the above example, a stable platform may be a subsystem within the Inertial Navigation System.

Field 8, Hardware or Software. This field identifies the problem as hardware, software or both.

<u>Field 9, Hazard Category.</u> This is the hazard category as determined by the analyst at the time the problem was identified. It will be either Category I (Catastrophic), Category II (Critical), Category III (Marginal) or Category IV (Minor).

Field 10, Disposition. This field is used to note the problem disposition as design change or no change.

Field 11, Manhours to correct Problem. Includes all program hours directed toward correcting the problem.

Field 12, Costs to Correct Problem. Includes all program costs incurred during the process of correcting the problem.

4.4.3 Summary of SCA Data Collection and Analysis Requirements

The database that results from this data collection effort will support further analyses and will support drawing important conclusions. This is possible where reports have been generated for providing data described in Section 4.3 and summarized by the checklist appearing in Table 4-1. Comparative analyses can then be performed to determine which type of analysis or test results in the greatest number of identified problems. Inclusion of the program phase and problem resolution costs gives even greater insight into past programs so that conclusions may be drawn. These might take the form of recommending analyses or tests which are best suited to a specific application. Others might recommend which analysis to perform in the early phase of a specific program. Still another might be a recommendation of tests which identify the greatest number of problems during later program phases.

In conclusion, this study will have succeeded if it has stimulated ideas on how collecting, organizing, analyzing and utilizing past data can improve the system acquisition process.

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Table 4-1. SCA Report Checklist

Major Concerns	Comments
Summary Information	
Has the analysis methodology been described?	Procedures should be described and computer resources (hardware and software) identified.
Has the analyzed circuitry been defined?	Identify the system/subsystem(s) and estimate their component size.
Has the time phasing for the analysis been identified?	State when the analysis was performed in terms of program milestones (i.e., prior to CDR).
Have the results of the analysis been summarized?	Include total number of sneaks identified, total number corrected, total number rejected.
Data Required for each Sneak	
Has the severity of each sneak been identified?	Use MIL-STD-1629 severity classifications.
Has the disposition of each sneak been identified?	Possible dispositions include problem corrected, falsely identified, ignored due to time/budget constaints.
Have tracking data been provided?	Include, as applicable, CCB date, CCB number, CCB Action.
Has the cost of correcting the problem been estimated?	Estimate the cost in terms of dollars and labor.

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Chapter 5 RECOMMENDATIONS FOR FURTHER STUDY

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This study has resulted in the development of a manual and an automated procedure for sneak circuit analysis. The procedures have been streamlined for simplicity and integrated into the design activity. The scope of this effort, however, did not include optimizing this integration, and several areas of research remain to be addressed in this connection.

5.1 CAD Integration

A more effective user interface can be attained by incorporating SCA results within the computer representation of the schematic. For example, sneak paths and devices or areas of the circuit that are the subject of design concerns could be highlighted. Additionally, availability of the schematic editor during SCA would permit real time evaluation of solutions to sneak problems. However, inherent limitations of the MS-DOS operating system and of the selected schematic capture tool preclude this type of integration. Alternative implementations should be investigated. As workstations and personal computer based, multi-tasking operating systems become more widely accepted, the above difficulties can be overcome by hosting SCAT in those environments.

An additional area of investigation for CAD integration is a design data base comprising parametric as well as schematic information for devices. This data would expand the SCA knowledge base and thus reduce the number of user queries. An evaluation of expert system shells that could best utilize this database would also be required.

5.2 Expansion and Integration of the Knowledge Base

One of the reasons for selecting an expert system over conventional programs for implementing the automated system was the relative ease for adding design concern rules. Due to the limited scope of the current study, many rules were not included. Further study should not only address the addition of more rules (and its resulting effect on system performance) but also the possibility of including these, particularly for the case of device oriented design concerns, as part of already existing design rule checkers that have been developed for most schematic capture products. Since many of the device oriented rules are only tenuously related to sneak circuits, it may be more effective to include them with a general set of design rules available to the designer after schematic capture.

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5.3 Net List Format

To permit compatibility with a wide range of CAD products, SCAT was designed to process net lists formatted in EDIF. At the time SCAT was developed, the only available version of EDIF was EIA Interim Standard No. 44, version 1 1 0. Subsequently, version 2 0 0 has become available and unfortunately is not compatible with older versions. An interface with the new version is therefore required.

Appendix A SCAT USER'S MANUAL

Note: This User's Manual has been written as a stand alone document and therefore contains information that may appear elsewhere in this Final Report where such information was also considered applicable for this manual.

A.1 INTRODUCTION

Sneak Circuit Analysis (SCA) is an established procedure for identifying sneak related problems (sneak paths, sneak timing, sneak labels/indications, design concerns, drawing errors) in electrical circuits. The procedure is specified as Task 205 in MIL-STD-785B where sneak circuits are defined as unintended paths that can cause an undesired function to occur or a desired function not to occur, assuming no component failures¹. A non-topological version of SCA is specified in MIL-STD-1543B where functional paths and design concerns are addressed.

Standard SCA procedures are highly labor intensive and process input data available only during the latter portion of the development cycle. Systems have been developed for automating the data-formatting portions of the procedure, but these require expensive computer resources (typically large, batch processing systems) and experienced analysts. The Sneak Circuit Analysis Tool (SCAT) overcomes these deficiencies by providing a personal computer based system for real time identification of sneak paths and design concerns early in the development cycle with no prior SCA experience required of the analyst. These features are attained in part by targeting the analysis to identify sneak paths in switching circuits, and in part by focusing the analysis at the assembly or subsystem level rather than the entire system. In this manner, most sneak problems can be identified and corrected by the responsible design engineer in a timely manner.

The automated analysis is based in part on the fact that sneak paths involve circuit branches that conduct current in either direction depending upon the switching state of the circuit. Thus, SCAT searches for these bidirectional branches rather than perform the more complex task of searching for specific topological circuit patterns as done by conventional automated SCA approaches. The analyst's task is also reduced to evaluating the significance of specific sneak paths rather than applying "clue lists" to circuit patterns for identifying the sneak paths.

¹ Sneak software analysis is not addressed here.

Since only a portion of a system is being analyzed at any given time, a feature has been provided to identify sneak paths associated with assembly or subsystem interfaces. SCAT requests the user to identify each interface port of a switching circuit in terms of it being a power input, ground return, or signal I/O. Interfaces to power and ground are labeled as such regardless of whether they respectively go to power and ground directly or through switched or unswitched loads, and they are included within the sneak path search. It is important to note that SCAT is intended to identify sneak conditions early in the design when interfaces may not yet be completely defined. In this manner, problems can be corrected early at minimal cost so that at a later development phase a more conventional SCA can be performed on the entire system and uncover the few, if any, remaining problems.

A.2 THE AUTOMATED PROCEDURE

The automated procedure for performing SCA consists of the following steps:

1. Target critical areas of a system for analysis.

The requirement for performing a SCA should apply to portions of a system considered critical. These subsystems can be identified from the results of other analyses such as FMEA or Fault Tree. Bear in mind that sneak path analysis addresses combinatorial power switching and distribution circuits and that design concern analysis, although applicable to all analog and digital circuitry, is not intended for identifying sneak paths. To insure thoroughness, all external interfaces of the targeted subsystems must be defined in terms of being dedicated power or ground, switched power or ground, or signal lines.

2. Partition the circuitry to be analyzed into manageable segments.

The appropriate size of a segment is a function of the following constraints:

- a. <u>The ability of the analyst to understand the detailed operation of the circuit.</u> The analyst must (1) evaluate the operational implications of each reverse current path identified by the sneak path search and (2) respond to SCAT queries concerning circuit timing and the function of circuit components. The size of the circuit must not exceed the analyst's capability to do so.
- b. <u>The ability to capture the circuit using OrCAD/SDT</u>. The circuit must be captured using OrCAD/SDT device libraries and editing guidelines specified in section A.5.
- c. <u>The ability of SCAT to process the circuit</u>. For typical circuit topologies, sneak path analysis can be performed on circuits containing up to 2,000 components while design concern analysis can be performed on circuits containing up to 300 components.

If circuit partitioning is required, minimize the number of interfaces crossing a partition boundary (see Figure A-1). This can usually be achieved by functionally partitioning the circuitry. As before, all interfaces must be defined in terms of being dedicated power or ground, switched power or ground, or signal lines.

- 3. Generate the EDIF net list following the procedure described in section A.5.
- 4. Run SCAT as described in section A.6.

A.3 SYSTEM REQUIREMENTS AND INSTALLATION PROCEDURE

SCAT is a menu driven system consisting of (1) a set of programs written in the C language and (2) knowledge bases developed under the M.1 (Teknowledge, Inc.) expert system shell, all running under MS-DOS and controlled by a DOS batch file program. The user must have a copy of M.1 to run SCAT. Hardware requirements are an 80286 or 386-based personal computer with a minimum of 640K RAM and a 10MB hard disk (an IBM-XT class machine can be used, but performance in terms of circuit size and analysis speed will degrade).



Figure A-1. Proper Circuit Partitioning

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Input data for SCAT is a schematic net list (*i.e.*, a list of device interconnections) formatted in $EDIF^2$ version 1 1 0 as generated by the OrCAD/SDT III schematic capture tool. OrCAD, a popular, commercially available MS-DOS based CAD package, is not bundled with SCAT.

The SCAT installation procedure is as follows:

- 1. Insure your computer's system configuration file permits 8 or more files to be open concurrently (*i.e.*, FILES = x where $x \ge 8$). For MS-DOS, the default value of the FILES parameter is 8.
- 2. You must have a copy of M.1 version 2.1 (or a later compatible release) installed on your hard disk in accordance with the vendor's (Teknowledge) installation instructions.
- 3. Copy all files from the SCAT program floppy disk on to your hard disk in the same directory as M.1.
- 4. Copy all net lists to be analyzed into the same directory as M.1. Net lists must be generated by OrCAD/SDT III using the "FlatEDIF" data format.

A.4 SCAT OPERATION

This section provides a detailed description of SCAT operation. This material is not required for understanding the operating procedure that appears in section A.6.

A complete list of names of SCAT programs and knowledge bases appears in Table A-1. Documented listings of the source code and knowledge bases appears in volume II of the final report. A list of temporary data files generated by the programs appears in Table A-2. SCAT programs controlled by the DOS batch file SCAT.BAT are shown by the diagram appearing in Figure A-2. The program names appearing in the figure are referred to in the following discussion.

Upon invoking SCAT, the net list entry screen generated by the knowledge base SCAFILE enables the user to specify a net list file to be analyzed. At this point, control returns to SCAT.BAT which invokes the C program EDIF2M1. This program reads the specified net list file and outputs a reformatted version in two files (DEVS.SCA and JOINS.SCA) for use by the M.1 knowledge bases. If the net list file is not found, SCAT.BAT calls the M.1 file SCAFILEB which displays an appropriate error message and re-reduests a net list file name. Otherwise, SCAT.BAT calls M.1 file SCAMENU which generates the "main menu" for SCAT.

² Electronic Data Interchange Format as specified by EIA Interim Standard No. 44. Version 2 0 0 was not available at the time this effort was undertaken.

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Table A-1. SCAT Programs, Knowledge Bases and Databases

File Name	File Type/Size	Description
SCAT.BAT	DOS batch file/1K	Controls overall program flow. Invoked by user.
DESIGN	KBase/12.3K	Identifies power/ground paths. Calls PATHS. Called by SCAMENU.
DEVICE	KBase/24.4K	Identifies device-related design concerns from the net list. Called by DSGNMENU.
DSGNMENU	KBase/5.9K	Function/device design concerns selection. Called by SCAT. Calls FUNCTION or DEVICE.
EDIF2M1.EXE	C Program/19.5K	Generates DEV.SCA and JOINS.SCA from the net list. Called by SCAT.
FUNCTION	KBase/46.1K	Identifies function-related design concerns from the net list. Called by DSGNMENU.
GOODPART.PTH	ASCII/.4K	Data base used by PATHS.
M1.EXE	M1 shell/231.6K	Expert system inference engine.
MODELS.SCA	ASCII/3K	Data base used by SCA and PATHS. Contains models for circuit devices.
PATHS.EXE	C Program/33.9K	Identifies power-power sneak paths. Called by SCAT.
SCA.CFG	M1 shell/2.4K	Display configuration data.
SCA.EXE	C Program/36K	Identifies sneak paths from the net list. Deleted parts and source/sink nodes are read from DATA.SCA. Called by SCAT.
SCAFILE	KBase/3.2K	Net list file selection. Called by SCAT.
SCAFILEB	KBase/3.6K	Reports net list file selection errors. Called by SCAT.
SCAIN	KBase/14.6K	Generates DATA.SCA. Reports presence of IC's in the net list. Called by SCAMENU.
SCAMENU	KBase/11.4K	Sneak paths/design concerns selection. Called by SCAT. Calls DESIGN or SCAIN.
SCAOUT	KBase/13.2K	Displays sneak paths. Assists user evaluation. Calls PATHS. Called by SCAT.

Table A-2. SCAT Data Files

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File Type/Size	Description
ASCII/**	Sneak paths identified by SCA for SCAOUT.
ASCII/*	Generated by SCAMENU. Contains switch, relay, and capacitor models.
ASCII/*	Power sources identified by DESIGN for use by PATHS. Also used as a flag file for SCAT to execute PATHS.
ASCII/*	Generated by SCAIN. Lists deleted net list parts and source/sink nodes.
ASCII/.03K	Initial system data for switch, relay, and capacitor models.
ASCII/.09K	Initial system data for source/sink nodes.
ASCII/*	Generated by SCAOUT and used by SCA. Contains deleted paths.
ASCII/*	Generated by EDIF2M1. Identifies all net list parts and ports. The file is used by various KBases.
ASCII/**	Flag generated by DSGNMENU for SCAT to execute SCAMENU.
ASCII/**	Flag generated by SCAMENU for SCAT to terminate and exit to DOS.
ASCII/*	Contains net list file name generated by SCAFILE or SCAFILEB for EDIF2M1 and SCA.
ASCII/*	Generated by EDIF2M1. Identifies circuit nodes in the net list. The file is used by various KBases.
ASCIī/*	Power-power paths identified by PATHS for FUNCTION.
ASCII/**	Flag generated by SCAIN for SCAT to execute SCA.
	File Type/Size ASCII/** ASCII/* ASCII/* ASCII/* ASCII/03K ASCII/03K ASCII/09K ASCII/* ASCII/*

* Varies with circuit size.** Program flag. Memory requirement is negligible.



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Figure A-2. SCAT Program

The main menu allows the user to modify switch, relay and capacitor models before choosing one of the following types of analyses:

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- (1) Sneak Path Search -- performed by the C program SCA and the knowledge bases SCAIN and SCAOUT.
- (2) Design Concern Analysis -- performed by the C program PATHS and the knowledge bases DESIGN, DSGNMENU, FUNCTION and DEVICE.

Sneak path search applies only to switching circuitry, *i.e.*, circuitry consisting of current interrupting devices (switches, relays, connectors, circuit breakers, fuses). Sneak paths are not traced through integrated circuits; IC's are instead automatically modeled by SCAT as open terminations (*i.e.*, IC leads are treated as open circuits). However, by using OrCAD to edit the schematic, the user can substitute equivalent circuits if he is aware of them.

SCAT searches for *potential* sneak paths by first identifying all directed, non-circular, topological paths between two user specified nodes; the "source" node (starting point) and the "sink" node (ending point). These paths are then analyzed to identify those that are bidirectional (*i.e.*, capable of conducting current in either direction depending upon the circuit's switching state. Each reverse current path identified is displayed to the user as an ordered list of device reference designators keyed to the circuit schematic. The user traces each reverse current path on the schematic to determine the path's validity (*i.e.*, whether system operation precludes the assumed switching state required by the path) and its significance (*i.e.*, its effect on mission success, personnel safety, equipment damage, *etc.*).

Reverse current paths are identified from the net list by the C program SCA. The knowledge base SCAIN enables the user to specify source and sink nodes and to set the switching state of any device. The knowledge base SCAOUT displays the reverse current paths and provides assistance in evaluating their validity. SCAOUT also allows the user to mark any reverse current path as invalid and regenerates the paths to eliminate the marked one and all others solely dependent upon it. A complete analysis requires that the sneak path search be re-run for all combinations of source and sink nodes involving power supplies (sources) and grounds (sinks).

Design Concern Analysis differs from Sneak Path Search in that the former is a highly interactive consultation and can be applied to any analog, digital or combined analog/digital circuitry. The analysis identifies problems associated with (1) circuit configurations involving specific devices (DEVICE knowledge base) and (2) circuit configurations involving circuit functions such as power distribution (FUNCTION knowledge base). Design concerns are implemented as knowledge base rules and comprise the *functional guidelines* and *device guidelines* appearing in the guidebook *Sneak Circuit Analysis for the Common Man*³. When a design concern is encountered, an appropriate message is

³ The guidebook's *design rules* for avoiding sneaks during design were not implemented during this effort because they apply functionally to the overall circuitry and are therefore much more difficult to automate.

displayed and the user is given the options of requesting an explanation of the problem and a possible solution. The analysis concludes by returning to the main menu.

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A.5 SCHEMATIC AND NET LIST GENERATION

Schematics must be drawn using the graphics and text editting tools and parts symbol libraries supplied by OrCAD/SDT III. The product includes print and plot utilities for generating hardcopies as well as a utility for generating net lists. Completed schematics are saved on disk and may be retrieved for additional editting. A complete description of the product can be found in the OrCAD user's manual and is not presented here.

Before generating a net list for input to SCAT, the schematic must be checked for the following:

- 1. All interfaces to external power sources and ground nodes must be labeled using the OrCAD/SDT *module port* facility.
- 2. The terminals of all in-circuit voltage sources (e.g., batteries) must be labeled using the OrCAD/SDT module port facility.
- 3. Any device appearing in the OrCAD/SDT *DEVICE* library may be used. The devices are shown in Figures A-3 and A-4. In addition, any IC may be used as long as it is referenced by the prefix "U" (see item 4).
- 4. Schematic reference designations for circuit components must use the default label prefix provided by OrCAD/SDT (*e.g.*, "R" for resistor one, "K" for relay, "U" for IC, *etc.*). Refer to Figures A-3 and A-4 for the default reference designator of each device.
- 5. Any labeled power, ground or signal path may be specified as a source or sink for Sneak Path Analysis. This may be done (1) while running SCAT by specifying the path name, or (2) while editing the schematic by labeling the desired module port as "SRC" or "SNK".

The OrCAD/SDT schematic error checking utility, ERC, can be used to check circuit connectivity for shorts between outputs, inputs with no driving source, unconnected pins and other common wiring errors.

The net list is generated using the OrCAD/SDT NETLIST utility. The special format "FlatEDIF" must be specified when invoking the utility.





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Figure A-4. Additional Schematic Symbols

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A.6 SCAT OPERATING PROCEDURE

Note: In the following procedure, data to be *entered* (*i.e.*, entry followed by carriage return) appear enclosed in chevrons (*i.e.*, <data>). Entries must be typed lower case. Do not type the chevrons. Entries to be *selected* are enclosed in quotes (*i.e.*, "selection"). Entries are selected by using arrow keys to highlight the selection and pressing ENTER. The selection "unknown" is not operative.

1. Enter <scat>.

A net list file name will be requested.

2. Enter the name of the net list file for the circuit to be analyzed. Use lower case text.

The file will be retrieved and pre-processed. This will typically take 5-10 seconds. If the file is not found, a bad-file message will appear and a net list file name rerequested. Otherwise, the main menu will appear and the user is requested to select the type of analysis to be performed.

3. Before proceeding to select Sneak Path Analysis ("sneak") or Design Concerns Analysis ("design"), the user has the option of modifying switch/relay and capacitor models to agree with their engineering specifications or usage. The contact arrangement for multiple-throw switches and relays (see Figure A-5) can be specified as Break-before-Make or Make-before-Break. In the former (the default case), when the switch or relay is toggled, the newly selected path is established *after* the old path has been opened. In the latter, there is some overlap for a short period (typically a few milliseconds) during which time the newly selected path and the old path exist concurrently. Models corresponding to these two configurations can be specified for switches and relays either individually or globally.

Capacitor terminals can be modeled as being unconnected to each other (*i.e.*, OPEN) or connected together (*i.e.*, SHORTed). The former (the default case) applies to paths involving DC currents while the latter applies to AC or transient current paths. As before, models corresponding to these two configurations can be specified for capacitors either individually or globally.

4. Option 1: Select "sneak" paths.

If the net list includes IC's, the user is informed that sneak path processing will treat paths to these devices as open circuits. The user has the option of continuing with the analysis or returning to the main menu.

If both a source node and sink node have not been specified in the schematic, the user is requested for these data.



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Figure A-5. Types of Switching Devices

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When source and sink nodes have been specified and if there are no IC's, or if there are and the user chooses to continue, the sneak path input data menu appears. The user may choose to:

- 4.1 Delete parts to simulate OPENed switches, remove redundant paths (thereby reducing processing time), delete paths for some other arbitrary reason. A list of the deleted parts and the reason for their deletion is maintained by the program.
- 4.2 Undelete previously deleted parts.
- 4.3 Change the source node for the analysis. If a node is labeled SRC on the schematic, it is the default source.
- 4.4 Change the sink node for the analysis. If a node is labeled SNK on the schematic, it is the default sink.
- 4.5 Execute the sneak path search.

Sneak path processing will commence. Processing time for small circuits (*i.e.*, short net lists) is a few seconds; larger circuits require more time. The reverse current path menu will appear when processing is concluded. Each path is identified by a list of device names corresponding to those in the circuit schematic that lie on the sneak path between the source and sink nodes. Devices that lie on the bidirectional portion of the path are prefixed by an "*". As an aid for cross-referencing the path list to the schematic, relays are listed with either a "-S" suffix to indicate a switching contact or a "-C" to indicate a coil. The analyst can trace the path on a copy of the schematic to facilitate its evaluation. The following options are available from the reverse current path menu:

- 4.5.1 Display the next path. Paths are consecutively numbered for reference.
- 4.5.2 Re-display the previous path. The path queue is circular.
- 4.5.3 Mark a reverse current path for deletion. This is required if user determines the path to be operationally impossible (*e.g.*, due to forbidden switching states).
- 4.5.4 Unmark a marked path. This option is available only when a path has been marked.
- 4.5.5 Display deleted paths. This option is available only when one or more paths have been deleted. The deleted path menu is similar to the reverse current path menu.

- 4.5.6 Regenerate paths. This option is available only when a path is marked for deletion or a deleted path is marked to be undeleted.
- 4.5.7 Print the path currently displayed (for hardcopy reference).
- 4.5.8 Request computer-aided analysis of the sneak path. The system will prompt the user for basic, circuit-related information necessary to evaluate the significance of the sneak path in terms of inhibiting desired functions or causing undesired functions. If as a result of the analysis the reverse current path is declared to not be a sneak path, the path will be automatically marked for deletion.
- 4.5.9 Return to the main menu.

The sneak path search should be repeated for all applicable source/sink pairs. These include each instance of the following combinations:

<u>SOURCE</u>

<u>SINK</u>

+ or - DC power input + DC power input AC power input - DC power input corresponding AC return

5. Option 2: Select "design" concerns analysis.

The following messages will appear.

- 5.1 <u>Power/ground message</u>. The analysis requires that power and ground paths be unambiguously identified. Automatic identification of the paths is initially attempted. The user is then asked to validate the power and ground listings and correct them if necessary. Additions or deletions are made by entering power (or ground) names one at a time. As described in the message, the names must appear as labels on the schematic and must be entered in lower case text. Spaces within the name must be replaced by underscores. Names prefaced by a number must be prefixed by "x_".
- 5.2 <u>Circuit type message</u>. The user must designate the circuitry being analyzed as either analog, digital, or both.

Prior to continuing, the currently identified power and ground nodes and the circuit type are displayed along with an option to modify them. If the design concerns analysis is repeated, this summary screen is displayed in place of the power/ground and circuit type screens.

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5.3 <u>Design concerns type message</u>. The analysis is divided into two parts, *functional* guidelines and *device* guidelines, to facilitate focusing on specific attributes of the circuit for analysis (or re-analysis). The user is requested to specify the analysis type.

From this point on, queries will arise as the system attempts to identify design concerns. The user must respond to each query for the analysis to continue. Queries addressing specific devices reference those devices by their schematic labels. Where switch or relay contacts are referenced, the specific terminals being addressed are indicated along with the device label (*e.g.*, K1-common1). The terminal identifiers are the same as those appearing in the OrCAD device library.

As each design concern is identified, an appropriate message is displayed. The user may request an explanation of the design concern, a possible solution, or re-display of the original message. The user is given an option for printing out identified design concerns at the conclusion of each guideline session.

A.7 SCAT APPLICATION EXAMPLE

Note: In the following procedure, data to be *entered* appear enclosed in chevrons (*i.e.*, <data>). Entries must be typed lower case, followed by a carriage return. Do not type the chevrons. Entries to be *selected* are enclosed in quotes (*i.e.*, "selection"). Entries are selected by using arrow keys to highlight the selection and pressing ENTER. The selection "unknown" is not operative. Figures for this section appear at the end of this section.

The example references the schematic DEMO (Figure A-6). SCAT will be used to identify a sneak path (shown highlighted in Figures A-12 and A-14) and a power-to-power tie (shown highlighted in Figure A-28). Entry of specific switch contact timing configurations (*i.e.*, Make-Before-Break or Break-Before-Make) will also be demonstrated. Figure A-29 depicting SCAT program flow, references the screens described in the following example.

- 1. Install SCAT on to hard disk as described in the SCAT Installation Procedure.
- 2. At the DOS prompt, enter <SCAT>. The net list entry screen (Figure A-7) will appear.
- 3. At the net list entry screen, enter <demo.net>. The main menu (Figure A-8) will appear.
- 4. At the main menu, select "sneak". The IC message (Figure A-9) will appear.
- 5. At the IC message, select "continue". The sneak input data menu (Figure A-10) will appear.

- 6. At the sneak input data menu, select "execute". The first reverse current path will appear.
- 7. At the reverse current paths menu (Figure A-11), observe Path 1 data. The path number appears at the top line of the APPLICATION DISPLAY window. Observe that a total of two reverse current paths were identified. A system reference number for the path also appears. Since no parts were deleted, the DELETED PARTS data, appearing below the path listing, are all empty (*i.e.*, []).

Path 1 is [K1-S,*S2,K1-C]. The path, shown highlighted in Figure A-12, comprises the source (labeled SRC on the schematic), a switch contact on relay K1, the switch S2, the coil of relay K1, and ground sink (labeled SNK on the schematic). The source and sink nodes do not explicitly appear in the path list but are implied.

Select "next" and "previous" and observe the path number change. An evaluation of the two reverse current paths identified reveals the critical one to be Path 1. The path permits source current flowing through relay K1 (when de-energized) and through switch S2 (when enabled) to also flow through the coil of K1, thus energizing the relay. This in turn will open the K1 contact, de-energizing the coil and starting an oscillatory sequence of events. Note that current through S2 flows opposite to that implied by Path 2: [Q1,*S2,LP2] (see Figures A-13 and A-14). Hence, S2 is bidirectional and is prefaced by an asterisk.

Select "return". The main menu will appear.

- 8. At the main menu, select "design". The power source menu (Figure A-15) will appear.
- 9. At the power source menu, select "continue". The ground list menu (Figure A-16) will appear.
- 10. At the ground list menu, select "continue". The circuit type menu (Figure A-17) will appear.
- 11. Answer the circuit type query "both". The summary of design parameters (Figure A-18) will be displayed along with options to modify any of them.
- 12 Select "continue". The design concern type menu (Figure A-19) will appear.
- 13. At the design concern type menu, select "functional_guideln". The function-oriented design concern analysis will commence.
- 14. A query will appear regarding power and ground connectors. Select "no".
- 15. A warning regarding a possible shock hazard at the ground pin will appear. Select "explanation". An explanation of the concern will appear. The page number at the end of the explanation references the page in the report SCA for the Common Man where additional information regarding this concern can be found.
16. Select "solution". A solution for the concern will appear. Note that as the text appears, earlier messages scroll off the APPLICATION DISPLAY window. These earlier messages can be retrieved by pressing function key F2 and using the arrow keys to scroll back through the text. To continue the analysis, F2 scrolling <u>must</u> be disabled by pressing the ESCAPE key.

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- 17. Select "warning_message". The original warning message is repeated.
- 18. Select "continue". A warning regarding switching devices in ground paths appears.
- 19. Select "return" (where available as a choice) or press ALT-A ("Alt" key and the letter "A") at any time to interrupt the analysis and return to the design concern type menu. Alternatively, the remaining functional design concerns may be viewed by repeatedly selecting "continue" until no further concerns have been identified. At that point, a hardcopy of the identified design concerns may be requested, or "return" may be selected to return to the design concern type menu.
- 20. At the design concern type menu (Figure A-19), select "device_guideln". The deviceoriented design concern analysis will commence.
- 21. A query regarding loads of specific transistors will appear. Select "yes".
- 22. A query regarding interruption of power at the collector terminal of specific transistors will appear. Select "q3" then select "q2".
- 23. A warning regarding a possible sneak path through the transistor will appear. The choices "explanation", "solution", "warning_message", "continue" and "return" may be selected as before.
- 24. Return to the design concern type menu by either selecting "return" (where available as a choice), pressing ALT-A, or repeatedly answering queries and selecting "continue" until the analysis concludes and then selecting "return".
- 25. At the design concern type menu, select "return". The main menu will appear.

At this point, the basic example concludes. Select "exit_program" to exit to DOS. Otherwise, proceed to step 26 to continue this example.

26. At the main menu (Figure A-8), select "model_switch". The switch/relay model menu (Figure A-20) will appear. Select "append_M". A prompt regarding specifying specific switches as Make-Before-Break will appear.

- 27. Enter $\langle s3 \rangle$ in response to the prompt (Figure A-21). Note the switch entry displayed in the DISPLAY window. Enter $\langle k1 \rangle$. Enter $\langle done \rangle$ to return to the main menu. Again, note the switch entry appearing within the message in the DISPLAY window (Figure A-22).
- 28. At the main menu, select "sneak". The IC message will appear.
- 29. At the IC message, select "continue". The sneak input data menu will appear.
- 30. At the sneak input data menu, select "execute". The system will search the net list for reverse current paths. The sneak paths screen will appear.
- 31. At the sneak paths screen, observe that four reverse current paths have now been identified. The additional two paths are due to relay k1 and switch s3 having been modeled as Make-before-Break.
- 32. Select "previous". Path 4, [Q1,*S2,K1-S,LP1], will appear (Figure A-23).
- 33. Select "analyze". A query regarding permissibility of simultaneous switching will appear. Select "no".
- 34. The system will conclude that reverse current Path 4 does not present a sneak problem and will mark the path for deletion (Figure A-24). This conclusion can be overridden by selecting the "undelete" option. Select "regenerate_paths".
- 35. The system will search the net list for reverse current paths under the constraint that the marked path is not a sneak path. Observe that only two paths were found (Figure A-25). The first of the four previous paths, [K1-S,LP2], is no longer a reverse current path due to the deletion of Path 4. Select "deleted paths".
- 36. The deleted paths screen will appear (Figure A-26). The options "next" and "previous" can be used to view deleted paths when more than one exists. The option "undelete" can be selected to mark a deleted path as a valid sneak path. Select "paths" to return to sneak paths menu.
- 37. Select "return". The main menu will appear.
- 38. At the main menu, select "design". A summary of the currently selected design concern analysis parameters will appear.
- 39. Select "continue". The design concern type menu will appear.
- 40. At the design concern type menu, select "functional_guideln". The function-oriented design concern analysis will commence.

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- 41. The first function-oriented design concern will now be a warning regarding a power-topower tie (Figure A-27). The corresponding sneak path appears in the message and may be traced on the circuit schematic (see Figure A-28). Note that this warning did not appear earlier when switch S3 and relay K1 were modeled as Break-Before-Make. As before, "explanation", "solution" or "warning message" may be selected.
- 42. Return to the design concern type menu by either selecting "return" (where available as a choice), pressing ALT-A, or repeatedly answering queries and selecting "continue" until the analysis concludes and then selecting "return".
- 43. At the design concern type menu, select "return". The main menu will appear.

44. At the main menu, select "exit_program". The DOS prompt will appear.



Figure A-6. Schematic of the Example Circuit

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M1 Commands APPLICATION DISP	LAY	
SCAT Ver. 1.3		
Developed By: Developed For: COTR:	SoHaR Inc. RADC/NBER c/n F30602-87-c-0193 B. Dudley (315) 330-2608	
Release Date:	10/2/89	
L		
Enter the name of	f the net list file:	demo.net
ALT-A Abort FZ	Scroll Display F10 Command	d Menu READY
	Figure A-7. Net List Er	ntry Screen

M1 Commands		
APPLICATION DISPLAY		
demo.net has been loaded		
Select SNEAK PATH SEARCH or DESIGN CONCERN ANALYSIS.		
Prior to selection, modify suitch,	relay, and capacitor models if necessary.	
- All switches and relays will be modeled as BREAK-BEFORE-MAKE unless otherwise specified.		
 All capacitors will be modeled as OPEN circuits unless otherwise specified. 		
	ANGUED	
Choose desired ontion!	nii Swen sweat	
- Sneak Path Search	design	
- Design Concern Analusis	model switch	
- Model switch	model capacitor	
- Model capacitor	levit program	
- Exit to DOS	unknown	
	LSpace to MarkL	
ALT-A Abort F2 Scroll Display	F10-Command Menu, READY	

Figure A-8. Main Menu

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M1 Commands	
APPLICATION DISPLAY	
The netlist contains ICs. If sneak path analys	is is performed, the ICs
will be ignored (creating "breaks" in the circu	it at these points).
If you do not wish to model the ICs in this man	ner, return to the
main menu at this time. Alternate modeling can	then be performed
by exiting to DOS, modifying the schematic to r	eplace the ICs with
switches and diodes, regenerating the netlist a	nd then running SNEAK
PATH ANALYSIS.	
OUESTION	ANSHER
Chases one of the following entions:	Continue
- Continue Speak Path Analusic	notunn
- Return to Main Manu	unknown
	unxnown
	Snace to Mark
ALT-A Abort F2 Scroll Display F10 Command M	lenu READY

Figure A-9. IC Message

M1 Commands		
APPLICATION DISPLAY		
Source: src		
Sink: snk		
Deleted Parallel Parts: []		
Deleted Switch Related Parts: []		
Deleted Miscellaneous Parts: []		
QUESTION		
Please choose desired option:	execute ·	
- Execute Sneak Path Search	delete	
- Delete Parts	lundelete	
- Undelete Parts	change source	
- Change Source	change sink	
- Change Sink	Ireturn	
	ISpace to Mark	
ALT-A Abort 'F2 Scroll Display F10 Com	and Menu	READS



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Figure A-11. Reverse Current Path 1



Figure A-12. Path 1 Highlighted on Schematic

M1 Commands APPLICATION DISPLAY		
[demo.net] src to snk reverse current path 2 of 2: path ref. number: 6		
[Q1,*S2,LP2] NOTE: Asterisk (*) indicates a reverse curre	ent device.	
Deleted Parallel Parts: []. Deleted Switch Related Parts: []. Deleted Miscellaneous Parts: [].		
Use	e up/down arrows to scroll answers.	
rquest ion-		
Choose: - Display Next Path - Display Previous Path - Analyze Current Path - Delete Current Path - Print Path - Return to Menu	next previous analyze delete priní return Space to Mark-	
ALT-A Abort F2 Scroll Display F10 Comma	nd Menu READY	

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Figure A-13. Reverse Current Path 2



Figure A-14. Path 2 Highlighted on Schematic

M1 Commands • APPLICATION DISPLAY		
 Identified external power sources: [ac_pwr,ac_rtn,src,x_plus5vdc]		
<pre>Verify the list. It must include all AC and + D sources. DO NOT APPEND any internal (in-circuit (e.g. in-circuit batteries). To append a name t 1) Type lower case. 2) Replace spaces with underscores (_). 3) Spell out '+' and '-' (i.e. 'plus' and ' 4) Any name starting with a number, a '+' or with 'x_'. eg. +5v dc => x_plus5v_dc.</pre>	OC EXTERNAL voltage) voltage sources to the list: minus'). a '-' should be prefixed	
QUESTION Choose one of the following: - no change - delete a name from present list - append a name to present list	ANSWER continue delete append unknown Space to Mark	
ALT-A Abort F2 Scroll Display F10 Command M	lenu READY	

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Figure A-15. Power Source Menu

M1 Commands	
APPLICATION DISPLAY-	
Identified grounds:	
[snk]	
Make sure the list is correct.	
L	
rquestion	ANSWER
Choose one of the following:	continue
– no change	delete
- delete a name from present list	append
- append a name to present list	unknown
	Space to Mark
ALT-A Abort F2 Scroll Display F1	lo Command Menu READY

Figure A-16. Ground List Menu

M1 Commands ,	
APPLICATION DISPLAY	
COUEST ION-	
Does the circuit consist of:	analog
- analog and electromech. devices only	digital
- digital IC's & passive devices only	both
- both analog and digital devices?	unknown
ALT & About F2 Sonall Disular F10 Comma	
Planet in Science Provide Proceeding	
Algure A-17. Circuit	i ype ivienu

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M1 Commands APPLICATION DISPLAY-Modify if necessary External Power Source: [ac_pwr,ac_rtn,src,x_plus5vdc] Ground: [snk] The circuit consists of: Both analog and digital devices. QUESTION-ANSWER-Choose: - Continue continue - Modify External Pouer List power_list - Modify Ground List gnd_list - Modify Circuit Type circuit_type - Return to Menu return unknown ^LSpace to Mark-ALT-A Abort F2 Scroll Display F10 Command Menu READY



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M1 Commands		
APPLICATION DISPLAY		
The following topics are covered under FUNCTI Power distribution and power switching Digital timing status indicators (i.e. lamps, LEDs)	ONAL guidelines:	
The following topics are covered under DEVICE guidelines: Bipolar transistors Op-amps Noise sensitive circuits (op-amps, one-shots, SCRs) Relays		
TTL or MOS digital circuitry		
-OUEST ION	- ANSWER	
Choose desired operation:	return	
	functional guideln	
- return to main menu	device_guideln	
- functional guideline	unknown	
• device guideline		
	Lispace to Mark	
ALT-A Abort F2 Scroll Display F10 Command	Menu READY	
Elana A 10 Declar Concern There Mana		

Figure A-19. Design Concern Type Menu

M1 Commands	· · · · · · · · · · · · · · · · · · ·	
PPLICATION DISPLAY-		
Select SNEAK PATH SEARCH or DESIGN CONCERN ANALYSIS.		
Pr.or to selection, modify suitch, relay, and c	apacitor models if necessary.	
- All switches and relays will be modeled as BREAK-BEFORE-MAKE unless otherwise specified.		
- All capacitors will be nodeled as OPEN circuits unless otherwise specified.		
FQUESTION-	TURNSWER	
Type of switching for relays and switches:	all'H'	
– MAKE-BEFORE-BREAK (M)	all 'B'	
- BREAK-BEFORE-MAKE (B)	append_M	
- Append MAKE-BEFORE-BREAK to list	delete_M	
- Delete MAKE-BEFURE-BREAK to list	return	
- Return to Main Renu	unknown	
ALT A Abort F2 Scroll Display F10 Command Menu READY		
Figure A-20. Switch/Relay Model Menu		

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Select SNEAK PATH SEARCH or DESIGN CONCERN ANALYSIS. Prior to selection, modify switch, relay, and capacitor models if necessary All switches and relays uill be modeled as DREAK-DEFORE-MAKE unless otherwise specified All capacitors will be modeled as OPEN circuits unless otherwise specified. QUESTION Enter name of MAKE-BEFORE-BREAK switches or relays to be added. Type 'done' when finished.	M1 Commands APPLICATION DISPLAY	
Prior to selection, modify switch, relay, and capacitor models if necessary. All switches and relays uill be modeled as BREAK-BEFORE-MAKE unless otherwise specified. All capacitors will be modeled as OPEN circuits unless otherwise specified. QUESTION—	Select SNEAK PATH SEARCH or DESIGN CONCERN	ANALYSIS.
QUESTION- Enter name of MAKE-BEFORE-BREAK switches or relays to be added. Type 'done' when finished.	 Prior to selection, modify switch, relay, All switches and relays uill be modeled as BREAK-BEFORE-MAKE unless otherwise All capacitors will be modeled as OPEN otherwise specified. 	and capacitor models if necessary. d specified. circuits unless
Lenter lowercase expression	QUESTION Enter name of MAKE-BEFORE-BREAK switches or relays to be added. Type 'done' when finished.	ANSWER 53 Enter Igwercase expression

Figure A-21. Switch Configuration Menu

M1 Commands APPLICATION DISPLAY		
Select SNEAK PATH SEARCH or DESIGN CONCERN ANALYSIS.		
Prior to selection, modify suitch, relay,	and capacitor models if necessary.	
- All switches and relays uill be considered as BREAK-BEFORE-MAKE except for the following list which will be modeled MAKE-BEFORE-BREAK: [s3,k1]		
 All capacitors will be modeled as OPEN circuits unless otherwise specified. 		
Choose desired ontion:	speak	
- Sneak Path Search	design	
- Design Concern Analysis	nodel switch	
- Model switch	model capacitor	
- Model capacitor	exit_program	
- Exit to DOS	unknown	
L	J Space to Mark	
ALT A Abort F2 Scroll Display F10 Com	mand Henu READY	

Figure A-22. Main Menu Listing M-B-B Switches

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M1 Commands	
APPLICATION DISPLAY	
[demo.net] src to snk reverse current path	4 of 4:
path ref. number: 9	
[Q1,*S2,K1-S,LP1]	
NOTE: Asterisk (*) indicates a reverse cur	rent device.
Deleted Parallel Parts: [].	
Deleted Switch Related Parts: [].	
Deleted Miscellaneous Parts: [].	
l l	se up/down arrows to scroll answers.
L	
rQUESTION	
Choose: - Display Next Path	next
- Display Previous Path	previous
- Analuze Current Path	115
I III III III III III III III III III	ana lyze.
- Delete Current Path	ana lyze. de lete
- Delete Current Path - Print Path	analyze delete print
- Delete Current Path - Print Path - Return to Menu	analyze delete print return
- Delete Current Path - Print Path - Return to Menu	analyze delete print return Space to Mark
- Delete Current Path - Print Path - Return to Menu ALT-A Abort F2 Scroll Display F10 Con	Analyze delete print return Space to Mark Mand Menu BFADY

Figure A-23. Reverse Current Path 4



Figure A-24. Path Marked for Deletion

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Figure A-25. Regenerated Reverse Current Path 1

M1 Commands	
TAPPLICATION DISPLAY-	
[demo.net] src to snk < <deleted>> path 1 of 1:</deleted>	
path ref.number: 9	
[Q1,S2,K1-S,LP1]	
NOTE: Asterisk (*) is NOT INCLUDED.	
Deleted Parallel Parts: [].	
Deleted Switch Related Parts: [].	
Deleted Miscellaneous Parts: [].	
DUESTION-	- ANSWER
Choose: - Display Next Path	Inext
- Display Previous Path	previous
- Undelete/Delete	lundelete
- Display Regenerated Paths	paths
- Print Path	print
	lunknown
	J LSpace to MarkL
ALT-A Abort F2 Scroll Display F10 Command I	Menu READY
	ha Carron



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M1 Commands		
APPLICATION DISPLAY-		
WARN ING :		
Check for possible power-to-power tie betwee when switching devices are closed. The snew following devices: path(1) = [K1,S3,K1,S1,F1]	en src and ac_pwr ak path(s) comprises the	
	ANSWER-	
choose one of the following options:	20mcmue	
	isolution	
	warning message	}
	return	1
	unknown	
	ⁱ Space to Mark	l_
ALT-A Abort F2 Scroll Display F10 Comm	and Henu	READY

Figure A-27. Power-to-Power Tie Warning Message



Figure A-28. Power-to-Power Tie Highlighted on Schematic

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Figure A-29. SCAT Program Flow

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Appendix B PROPOSED REVISIONS TO DI-R-7083

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DATAIT			TIFICATION HOIST
		AGENCY	AJBBUA
SNEAK CIRCUIT ANALYSIS REP	DRT	DoD	DI-R-7053
The Sneak Circuit Analysis lyses performed to verify	documents the results of ana- the absence or presence of hidd	80 D	EC 15
equipment or software. The any latent flow packs that	puts, or undesirable functions s results of the analyses ident could cause unexpected operati	of ify USAP ons was assor	
action proposed to eliminate ology used in, and the exc	duare or software and correctiv te them. It details the machod ant and depth of, the analyses.	• • •	. LIWITATIEN
The Sneak Circuit Analysis which the Covernment procu-	provides documentation from rink activity can make determin		
ations concerning system ar or inhibition of desired for component failure. HIL-ST	nd equipment unwanted functions unctions in the Absence of D-7858 (Task 205) must be cited	* #EFERENC Now (0)	E) /Jan defory as clead in
in conjunction with the use	of this DID.	* HIL-ST	D-7858 (Task 205
This DID supersedes DI+R-22	2594.		
		CHOB EXE	H
		TANSC 40	F3104
The Sneak Circuit Analysis	shall include the following dat		
 Description of the ments for Sneak Circuit And 	ne mechodology and procedures us slysis as scipulated in MIL-STD	sed co sacisf; -7858 (Task 20	y che require- D5).
(2) Results of the ar sufficient detail to demons	alysis and corrective actions a actions that the sneak path will	taken or anti- be eliminated	cipated, in 1.
Analyses shall be in the co	ntractor's own format.		

Exhibit B-1. DI-R-7083

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	2 10ENT1F1C	TION NO(3)
	ACENCY	NUMBER
1. TITLE SNEAK CIRCUIT ANALYSIS REPORT	DoD	DI-R-7083 Rev.
3. DISCRIPTION/PURPOSE Sneak Circuit Analysis (SCA) documents the results of analysis performed on hardware and software systems to identify designed-in conditions that could inhibit or produce undesired system functions which could analyze the form a software statem	4. APPROVAL I S. OFFICE OF	PRIMARY RESPONSIBILITY
success or cause equipment damage. This report details the analysis methodology and the status of each sneak problem identified as a result of SCA. It provides insight into the extent and depth of the SCA.	6. DOC REQUIN	
	8. APPROVAL 1	LIMITATION
 APPLICATION/INTERRELATIONSHIP This SCA Report provides data which may be used by the procuring activity for statistical analysis and, further, to determine SCA cost-effectiveness. 	 REFERENCE: block 10) "MIL-STD 	5 (Kandatory as cited 1) 1-785B (Task 205)
7.3 This DID is applicable when a Sneak Circuit Analysis is required and performed in accordance with MIL-STD-785B (Task 205).	NCSL NURBER (S)	
7.4 This DID may be applied to any contract during the		
10.2 Content. The SCA Report shall include the following 10.2.1 Hethodology. A description of the methodology and requirements for SCA as stipulated in MIL-STD-785B (Task 205). Spectration of the start and the structure of t	data: procedures us cify compute	ed to satisfy the r resources and
10.2.2 Summer A	Include prob	Jama analystand
10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identif falsely identified, etc. Estimate total number of components in ea analyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks ident include information from reports such as Sneak Circuit Report. Desi	Include prob ytical techn fied, number ch system or CDR but prio lfied through an Concern R	plems encountered iques which aided corrected, numbe subsystem r to FCA, after 'SCA. This shall eport. Drawing
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifialsely identified, etc. Estimate total number of components in ea analyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks ident include information from reports such as Sneak Circuit Report, Desi Error Report, Sneak Software Report, Software Design Concern Report Report, etc. As a minimum, the list shall include the following data 	Include prob ytical techn fied, number ch system or CDR but prio Ified through gn Concern R , Software D ta for eacn	blems encountered iques which aided corrected, numbe subsystem r to FCA, after i SCA. This shall eport, Drawing ocument Error sneak:
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifalsely identified, etc. Estimate total number of components in ea analyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks identification from reports such as Sneak Circuit Report, Desi Error Report, Sneak Software Report, Software Design Concern Report Report, etc. As a minimum, the list shall include the following da A. Date. Provide date the sneak was identified. 	Include prob ytical techn fied, number ch system or CDR but prio Ified through gn Concern R , Software D ta for eacn	blems encountered iques which aided corrected, numbe subsystem r to FCA, after of SCA. This shall eport, Drawing ocument Error sneak:
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifalsely identified, etc. Estimate total number of components in ea analyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks identification from reports such as Sneak Circuit Report, Desi Error Report, Sneak Software Report, Software Design Concern Report Report, etc. As a minimum, the list shall include the following da A. Date. Provide date the sneak was identified. B. Sneak Number. Provide the contractor-assigned r the identified sneak. 	Include prob ytical techn fied, number ch system or CDR but prio Ified through gn Concern R , Software D ta for eacn eference num	blems encountered iques which aided corrected, numbe subsystem r to FCA, after of SCA. This shall eport, Drawing ocument Error sneak:
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifalsely identified, etc. Estimate total number of components in ea analyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks identification from reports such as Sneak Circuit Report, Desi Error Report, Software Design Concern Report Report, etc. As a minimum, the list shall include the following da A. Date. Provide date the sneak was identified. B. Sneak Number. Provide the contractor-assigned r the identified sneak. C. Title. Provide title of the identified sneak. 	Include prob ytical techn fied, number ch system or CDR but prio lfied through gn Concern R , Software D ta for eacn eference num	blems encountered iques which aided corrected, number subsystem r to FCA, after of SCA. This shall eport, Drawing ocument Error sneak:
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifalsely identified, etc. Estimate total number of components in ear analyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks identificed information from reports such as Sneak Circuit Report, Desi Error Report, Sneak Software Report, Software Design Concern Report Report, etc. As a minimum, the list shall include the following da A. Date. Provide date the sneak was identified. B. Sneak Number. Provide the contractor-assigned r the identified sneak. C. Title. Provide title of the identified sneak. D. System/Subsystem. Applicable system or subsystem 	Include prob ytical techn fied, number ch system or CDR but prio lified through gn Concern R , Software D ta for eacn eference num m in which so	blems encountered iques which aided corrected, numbe subsystem r to FCA, after of SCA. This shall eport, Drawing ocument Error sneak: ber for neak is located.
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifalsely identified, etc. Estimate total number of components in earnalyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks identification from reports such as Sneak Circuit Report, Design Concern Report Report, etc. As a minimum, the list shall include the following data. A. Date. Provide date the sneak was identified. B. Sneak Number. Provide the contractor-assigned r the identified sneak. C. Title. Provide title of the identified sneak. D. System/Subsystem. Applicable system or subsyste E. Sneak Category. Identify the sneak category as: 	Include prob ytical techn fied, number ch system or CDR but prio lfied through gn Concern R , Software D ta for eacn eference num m in which so	blems encountered iques which aided corrected, numbe subsystem r to FCA, after i SCA. This shall eport, Drawing ocument Error sneak: ber for neak is located.
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifalsely identified, etc. Estimate total number of components in earnalyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks identification from reports such as Sneak Circuit Report, Desi Error Report, Sneak Software Report, Software Design Concern Report Report, etc. As a minimum, the list shall include the following data. A. Date. Provide date the sneak was identified. B. Sneak Number. Provide the contractor-assigned relation of the identified sneak. C. Title. Provide title of the identified sneak. D. System/Subsystem. Applicable system or subsyste E. Sneak Category. Identify the sneak category as: (1) Sneak Path. Current, energy or logical along an unexpected path or in an unition 	Include prob ytical techn fied, number ch system or CDR but prio lfied through gn Concern R , Software D ta for eacn eference num m in which s sequence is	blems encountered iques which aided corrected, numbe subsystem r to FCA, after i SCA. This shall eport, Drawing ocument Error sneak: ber for neak is located. caused to flow. on.
 10.2.2 Summary. A program summary of the results of SCA. accomplishing the analysis and program elements, procedures or anal accomplishing the analysis. Provide summary of total sneaks identifialsely identified, etc. Estimate total number of components in ea analyzed. Identify when SCA was accomplished (prior to CDR, after FCA). 10.4 Status. Provide a table which lists all sneaks identificude information from reports such as Sneak Circuit Report, Desi Error Report, Sneak Software Report, Software Design Concern Report Report, etc. As a minimum, the list shall include the following da A. Date. Provide date the sneak was identified. B. Sneak Number. Provide the contractor-assigned r the identified sneak. C. Title. Provide title of the identified sneak. D. System/Subsystem. Applicable system or subsystem E. Sneak Category. Identify the sneak category as: (1) Sneak Path. Current, energy or logical along an unexpected path or in an unitut (2) Sneak iming. Events occur in an unexpected path or in	Include prob ytical techn fied, number ch system or CDR but prio lified through gn Concern R , Software D ta for each eference num m in which s sequence is ended directi	blems encountered iques which aided corrected, number subsystem r to FCA, after of SCA. This shall eport, Drawing ocument Error sneak: ber for neak is located. caused to flow. on.

Exhibit B-2. Proposed Revision to DI-R-7083 (Page 1 of 3)

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BLOCK 7 (CONTIN	VED)
	Phase, Full Scale Development Phase ard/or Production Phase, through DD form 250 sign off.
7.5	The CDRL should specify initial submittal prior to Critical Design Review and final submittal prior to Functional Configuration Audut.
7.6	The Contract Data Requirements List (CDRL) should specify whether this document is to be prepared and delivered on bound 8 $1/2 \times 11$ inch bond paper or electronic media. If electronic media is selected, the precise format must be specified.
This DID su	perseded DI-R-7083.
BLOCK 10 (CONT)	NVED)
	operating conditions, and thus may result in an undesired action taken by an operator.
	(4) Sneak Label. A label which incorrectly or imprecisely labels system functions (e.g., system inputs, controls, displays, buses, etc.) and thus mislead an operator.
	F. Nature of the Sneak. Identify the causal nature of the sneak as:
	(1) Specification Error
	(2) Design Error
	(3) Manufacturing Error
	(4) Other
	G. Sneak Severity Category. Identify sneak category as:
	(1) Category I (Catastrophic). May cause death or weapon system loss.
	(2) Category II (Critical). May cause severe injury, major property damage, or major system damage which will result in mission loss.
	(3) Category III (Marginal). May cause minor injury, minor property damage or minor system damage which will result in delay or loss of availability or mission degradation.
	(4) Category IV (Minor). Not serious enough to cause injury, property damage or system damage but will result in unscheduled maintenance or repair.
	H. Disposition. Indicate if a change was implemented and implementation details. If a change was not implemented, provide reason for not implementing the suggested change. For example:
	(1) False ID. The sneak problem was falsely identified.
	(2) No Problem. The sneak design aid not manifest itself into a sneak problem.
	(3) Ignored. The sneak effect was operationally insignificant or would not cause functional failures.
	(4) Time/Budget. Program time or budgetary constraints outweighed the risk associated with not making the change.
	 CCB Date. If the resultant design deficiency was presented to the Configuration Control Board, provide the date.
	J. CCB Number. Configuration Control Board assigned number (if applicable).
	X. CCB Action. Action taken upon initial presentation to Configuration Control Board.
	L. Manhours. Estimate manhours required to correct sneak.

Exhibit B-2. Continued (Page 2 of 3)

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BLOCK 10 (CONTINUED)

- M. Cost. Estimate cost to correct sneak.
- N. Status/Date. Status of sneak report. Status date shall be within 15 days of DID submittal.



Appendix C PROPOSED REVISIONS TO DI-R-7080

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	DATA ITEM DESCRIPTION	2. HOENT	IFICATION BOIST.
TITLE		ARRICY	
RELIANT	TTY STATUS BYPOPT	D DD	DI-2-7080
BEACHIPT	HAN PURPOSE	-	0475
Ta monte	or and evaluate conversate arrayase and accomplish	80 0	CT 14
ments in	a conducting the Reliability Program for the	REMONES	4.177
applical	ble contract end item(s).	USAF	
			••••
		-	LIMITATION
APPLICAT	T 10 10/ 10 7 E # # EL ATION BUIP	-	
Applical	ble to contracts which contain the requirement for		
reliabi (Task 10	lity Program Reviews in accordance with MIL-STD-7858 03).	. BEFERENC	ES (Jannassary on Citori in
This DI	D supersedes DI-R-1731 and DI-R-2119.	*HIL-ST	D-785B (Task 101
			A124
		AHSC N	6. F3104
	4710% INSTRUCTIONS	030	· 5
1. Eacl	h report shall include the following information as a	minimum:	
a. stateme:	The work accomplished and results obtained on each t nt or the Contractor's Reliability Program Plan.	task define	d by the work
b. at the	Summaries of the status of previously reported progr close of the last reporting period.	rams which	were unresolved
с.	A list of current problems containing:		
	(1) A serial number assigned to identify the proble	em.	
	(2) The date on which the problem was first detected	ed.	
	(3) A short statement identifying the problem and	its effect	
	(4) The activity assigned to work on the problem.		
	(5) The expected resolution and date to be achieved	d.	
- • b c = -	(6) A short statement of accomplishment to-date or eports.	a cross-r	eference to
other r			

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Exhibit C-1. DI-R-7080 (Fage 1 of 2)

DI-R-7080 lock 10. PREPARATION INSTRUCTIONS (Continued)

d. A specific accounting of each design review action item remaining open at the end of the last report period including a full description of the action taken on each item.

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e. Identification of observed potential reliability problems introduced by Government-furnished equipment and descriptions of accommodations or improvement changes deemed necessary to make such equipment compatible.

2. The report shall include a graphic discussion of trends. A breakdown to the configuration item level shall be made in the following manner:

Requirement	Allocated Value	Predicted Value	Observed Value
	1		

3. The report shall include proposed changes to the Reliability Program Plan (as applicable).

4. The Final Status Report can be identified as the Program Summary Report.

Page 2 of 2 Pages

Exhibit C-1. Continued (Page 2 of 2)

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DATA ITEM DESCRIPTION	2. IDENTIFICA	CICH HOLT
· · · · · · · · · · · · · · · · · · ·	AGENCY	NUMBER
1. TITLE RELIABILITY STATUS REPORT	DoD	DI-R-7080 Rev.
3. DESCRIPTION/FURFOSE To monitor and evaluate contractor's progress and accomplishments	4. APPROVAL D	2772
end item(s).	5. OFFICE OF	PRIMARY RESPONSIBILITY USAF
	6. DOC REQUIR	20
	*. APPROVAL 1	INITATION
7. APPLICATION/INTERRELATIONSHIP		
reliability Program Reviews in accordance with MIL-STD-785B (Task 103).	9. REFERENCES	(Mandatory as cited in
This DID supervises by D 1011 and by D 2110	block 10) *MIL-STD	-785B (Task 103)
This Did supersedes DI-R-1731 and DI-R-2119.		
	HCSL NUMBER (S)	
10. PREPARTION INSTRUCTIONS 1. Each report shall include the following information as a minimu	nt	
a. The work accomplished and results obtained on each task or the Contractor's Reliability Program Plan.	defined by t	he work statement
b. Summaries of the status of previously reported programs close of the last reporting period.	which were u	nresolved at the
c. A summary table of all identified design problems. The	list shall b	e on two parts.
(1) Part 1 will list current (open) problems and sh	all contain:	
(a) Serial number assigned to identify each	probler.	
(b) Date on which problem was first detected		
(c) Short statement identifying the problem	and its effe	et.
(d) Activity assigned to solve the problem.		
(e) Expected resolution and date to be achieved	ved.	
(f) Short statement of accomplishment to dat other reports.	e or a cross	-reference to
(2) Part 2 will begin on a new page and contain a s identified during the program. The list shall	ummary table contain:	of all problems
(a) Serial number assigned to identify each	problem.	
(b) Date on which problem was first detected	•	
(c) Date the problem was resplyed.		
(d) Title of the problem report.		

Exhibit C-2. Proposed Revision of DI-R-7080 (Page 1 of 2)

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BLOCK 10 (CONTINUED)			
(f) Brie tran	f description of each p sition, component failu	problem (sneak circuit, pre, etc.)	unintentional state
(g) The (Sne Anal test	analytical tool or test ak Circuit Analysis, Fa ysis, Failure Mode, Eff , etc.).	method used to identi ult Tree Analysis, Fin fect Analysis, burn in	fy each problem ite State Machine test, integration
(h) Haza	rd Category if identifi	ed.	
d. A specific accountin the last report peri	g of each design review od including a full des	action item remaining	open at the end cf taken on each item.
 e. Identification of ob furnished equipment necessary to make su 	served potential reliab and descriptions of acc ch equipment compatible	oility problems introdu commodations or improve	iced by Government ment changes deemed
 The report shall include a distance in the shall be made in 	graphic discussion of t the following manner:	rends. A breakdown to	the configuration
Requirement	Allocated Value	Predicted Value	Observed Value
3. The report shall include or	contract observes to the B	eliability Program Pla	
3. The report shall include pr	oposed changes to the R	eliability Program Pla	n (as applicable).
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Exhibit C-2. Continued (Page 2 of 2)

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Annotated Bibliography

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A review of design analyses (including Stress, Worst Case, Safety, Sneak Circuit) that contribute to fuze design. Benefits, limitations and potential problems are evaluated for each analysis. Suggests ways in which SCA compliments Safety Fault Tree and FMEA. [Note: Distribution of this document is authorized only by DoD agencies.]

2. Boeing Co., Electrical Analysis of B-52/FB-111 AMAC and Release Circuitry Utilizing Sneak Circuit Analysis Techniques, report D2-118576-1/2/3 (AD-A103951/2/3), October 1975.

Final report of a combined sneak circuit analysis and loading (cable power shorting) analysis. Includes network trees, sneak circuit reports.

3. Boeing Aerospace, Sneak Circuit Analysis of F-104/DCU-201/GWM-4 Nuclear Weapon Controller/Tester Subsystem, (AD-B103044), February 1978.

Sneak circuit, design concern and drawing error reports. The reports include USAF follow-up action. [Note: Distribution of this document is limited to DoD or U.S. DoD contractors.]

4. D. L. Buratti and S. G. Godoy, *Sneak Analysis Application Guidelines*, RADC-TR-82-179 (AD-A118479L), June 1982.

General SCA background with detailed information on project management. Includes a comparison of SCA with related analyses and an overview of interfacing SCA with CAD.

5. A. H. Carter, K. T. Budnick and S. R. Douglass, "Computer Produced Drawings for Circuit Analysis," *Proc. RAMS*, January 1985, pp. 224-229.

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6. R. C. Clardy, "Sneak Circuit Analysis," in J. E. Arsenault and J.A. Roberts (ed.), *Reliability and Maintainability of Electronic Systems*, Computer Science Press, 1980, pp. 223-241.

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7. T. Jackson, "Integration of Sneak Circuit Analysis with FMEA," Proc. RAMS, January 1986, pp. 408-414.

A description of Functional SCA (FSCA), functional clues, integration with FMEA, and FSCA examples.

8. MIL-STD-1543B, Reliability Program Requirements for Space and Missile Systems, 25 October 1988.

Para. 204.2.8.2 specifies application of design clues (Appendix C of std.) during hardware FMEA. Para. 204.2.8.6 specifies application of functional clues (Appendix B of std.) during functional FMEA. Task 205 specifies performance of a Design Concern Analysis (DCA) using a design concern clue list (Appendix D of std.).

9. MIL-STD-785B, Reliability Program for Systems and Equipment Development and Production, 15 September 1980.

Task 205 defines SCA as a method to "... identify latent paths which cause unwanted functions to occur or which inhibit desired functions... All components shall be assumed to be functioning properly." Paragraph 50.2.3.2 describes SCA as applicable to critical systems, not to off-the-shelf hardware. Also describes SCA as being costly and performed too late in the development cycle. Paragraph 60.1 of this standard references data item DI-R-7083, SCA Report.

10. J. Miller, Sneak Circuit Analysis for the Common Man, RADC-TR-89-223, October 1989.

Presents a manual procedure for SCA in a simple, easy to follow format. Includes a description of common design errors which can lead to sneak circuits as well as guidelines for identifying functional and device oriented sneak problems. The procedure is targeted for use early in the design phase as well as for existing systems.

11. R&M-STD-R00205, Sneak Circuit Analysis, Naval Avionics Center Reliability & Maintainability Std, 29 May 1986.

Government standard for performing hardware and software sneak analysis. Includes recommended phasing and examples of SCA projects, completed reports, contractual SoWs, DIDs. 12. Dept. of Navy, Contracting and Management Guide for Sneak Circuit Analysis (SCA), NAVSEA-TE001-AA-GYD-010/SCA (AD-A094541), September 1980.

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Addresses SCA benefits, problems, cost-factors, tradeoffs, comparison with other analyses, integration with CAD/CAE, manual vs. automated techniques. Includes examples of SOWs and DIDs.

13. Dept. of Navy, Sneak Circuit Analysis: A Means of Verifying Design Integrity, NAVSO P3634 (stock no. 0518-LP-394-8000), July 1986.

SCA implementation details for a generalized, computer-aided procedure. Includes cost estimation, clue lists, analysis example, and other applications for the network tree data base. Principle contributors were General Dynamics & Boeing.

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Methodology and specific details of SCA procedure used on Apollo program. Describes data encoding, circuit partitioning, network tree generation and a basic clue set.

15. P. F. Stokes and G. Buckley, Sneak Circuit Analysis of FMU-112/B Fuze and Electrical Generating System, AFATL-TR-75-133 (AD-B031159L), Sept. 1975.

Primarily a digital SCA at both the system and device (IC) level. Most of the identified sneaks resulted from postulated failures as in an FMEA.

 J. L. Vogas, "Verification of Hardware/Software Integration Through Sneak Analysis," paper presented at American Defense Preparedness Association Forum 81, 27 October 1981.

Includes SCA and Software Sneak Analysis background information and simplified examples of combined hardware/software sneak analysis.

 J. L. Wilson and R. C. Clardy, "Sneak Circuit Analysis Application to Control System Design," *Integrity in Electronic Flight Control Systems*, AGARD-AG-224, AD A041042, April 1977, pp. 12:1-6.

Includes a description of the Mercury-Redstone launch failure in 1961 that was attributed to a sneak circuit.

Glossary

The definitions provided for the following terms apply only insofar as the terms are used in this report.

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- Break-Before-Make Refers to any switching device (*e.g.*, switch, relay, contactor) having a multiple contact arrangement such that upon being switched the selected contacts will close (*i.e.*, "make") only after the de-selected contacts open (*i.e.*, "break").
- Clue A statement or question directed toward the SCA analyst regarding the presence of a specific condition that past experience has shown to have caused a sneak circuit. Clues are of two basic types: (1) Those associated with circuit topological patterns and (2) those associated with specific devices or circuit configurations.

Cyclic Path Any closed (*i.e.*, circular), topological path through a circuit.

EDIF Electronic Data Interchange Format, an industry standard governing the transfer circuit data such as electrical schematics between computer aided design tools.

- Expert System Shell The basic software (the *inference engine*) required for processing a set of rules constituting a knowledge base application, and the software facilities for developing and maintaining the knowledge base.
- Fault Tree Diagrams employing a special, logic-type symbology for depicting the hierarchical dependency of higher level failure events on lower level events.
- Finite State Used in reference to analyses utilizing Markov models or Petri net diagrams where the operation of a system can be represented by transitions between a finite number of processes or states.
- Functional Net A functional block diagram depicting power distribution and control and major signal flow between system functional elements.
- H Pattern A topological pattern within a network tree. The branches of the pattern form an "H" such that power flows into the branches at the top and out the branches at the bottom. The branch represented by the cross bar of the "H" can potentially conduct current in both directions and therefore may be a sneak path.

K Base File A knowledge base file, *i.e.*, a computer file containing a set of rules constituting a knowledge base.

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MBB Switches See Make-Before-Break.

Make-Before-Break Refers to any switching device (*e.g.*, switch, relay, contactor) having a multiple contact arrangement such that upon being switched the selected contacts will close (*i.e.*, "make") before the de-selected contacts open (*i.e.*, "break").

M.1 The trademark of a commercially available expert system shell from Teknowledge, Incorporated.

Net List A textual listing of the circuit interconnections and devices appearing in a graphical schematic. Various formats including EDIF are available for organizing the list.

- Network Tree A diagram depicting a small, functional portion of a system's circuitry with all extraneous interconnections and devices removed so as to highlight the circuit topology. The tree is drawn such that power flows from top to bottom and signals flow from left to right. Elements of the tree are cross-referenced to the detailed electrical schematic(s) from which the tree was derived.
- Non-cyclic Path A topological path through a circuit in which the path progresses without ever crossing back upon itself.
- OrCAD The trademark of a commercially available schematic capture product from OrCAD Systems Corporation.
- Schematic Capture The process of generating, editting, and saving an electrical schematic on a computer.
- X Pattern A topological pattern within a network tree. The branches of the pattern form an "X" such that power flows into the branches at the top and out the branches at the bottom.
- Y Power Dome A topological pattern within a network tree. The branches of the pattern form a "Y" such that power flows into the branches at the top and out the branch at the bottom.

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